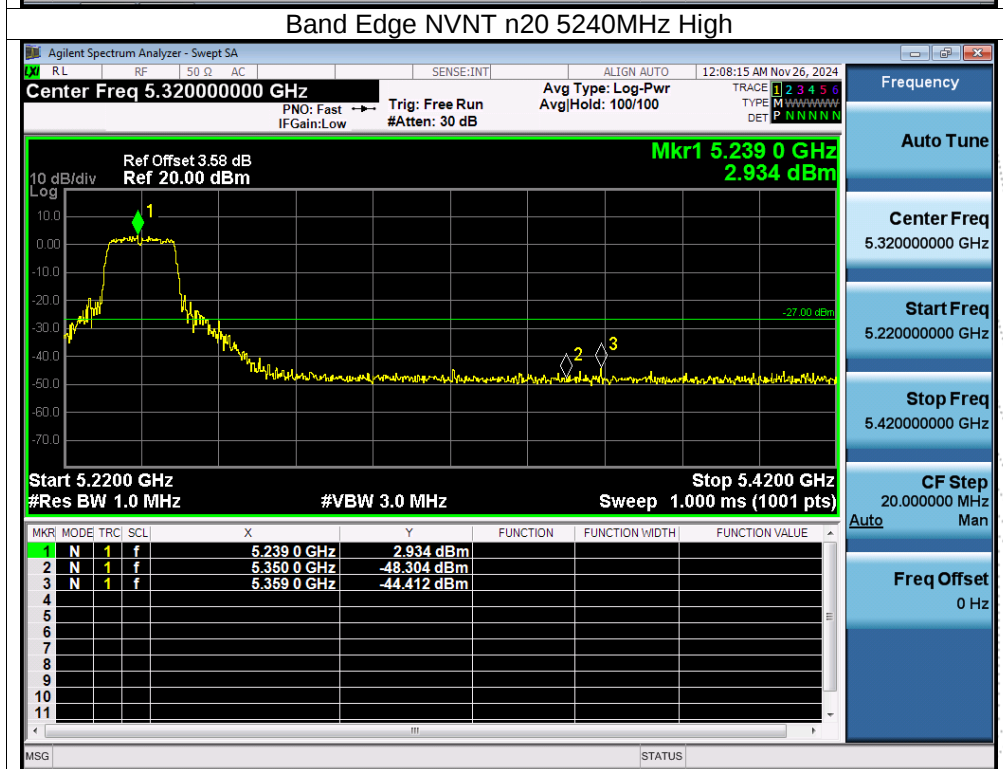
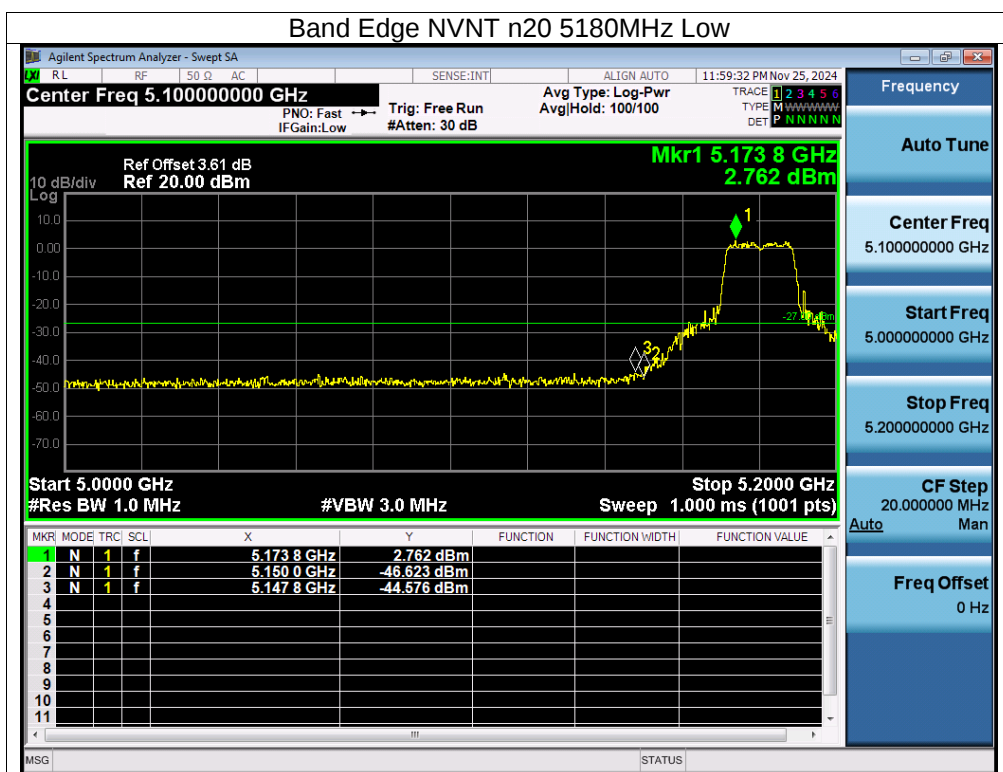
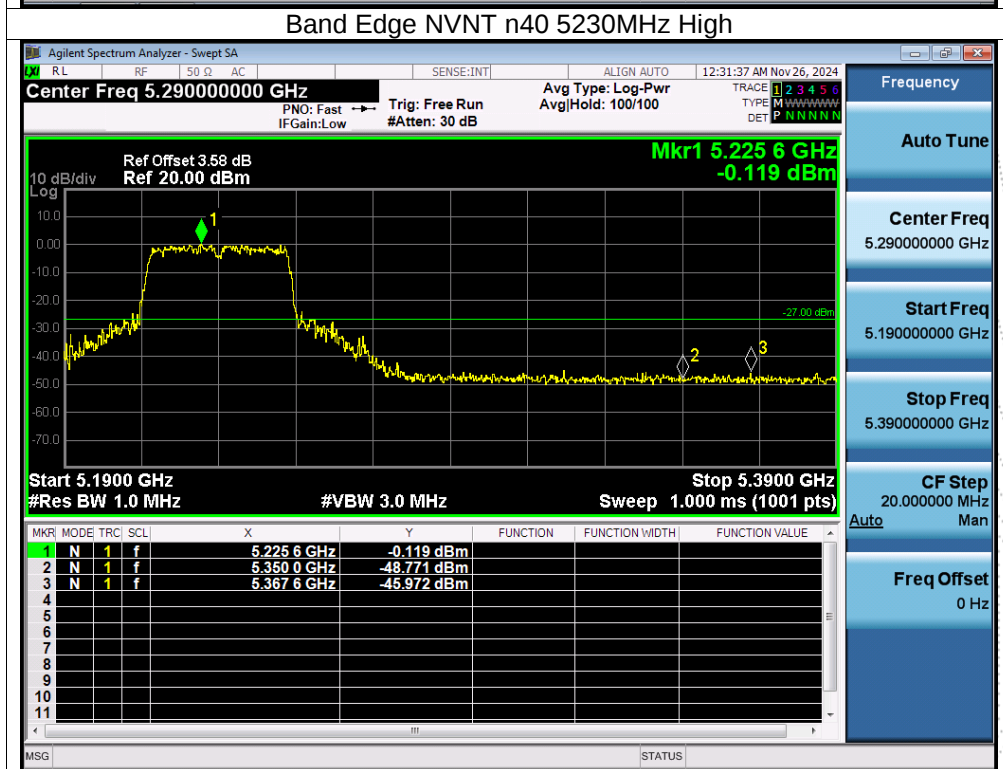
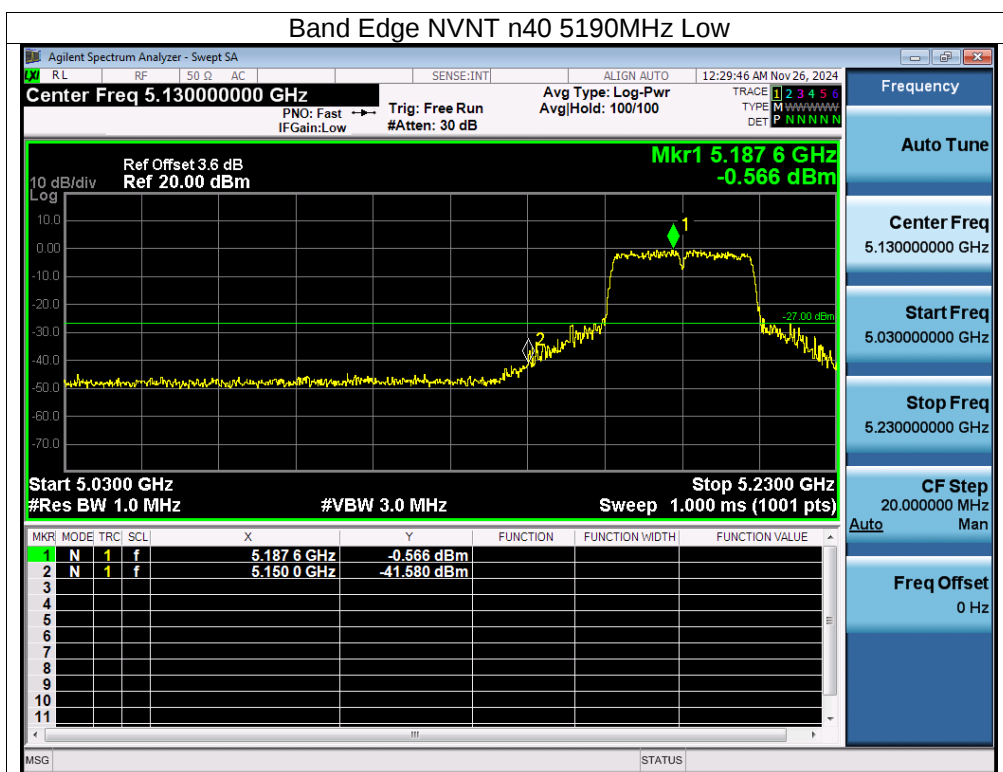
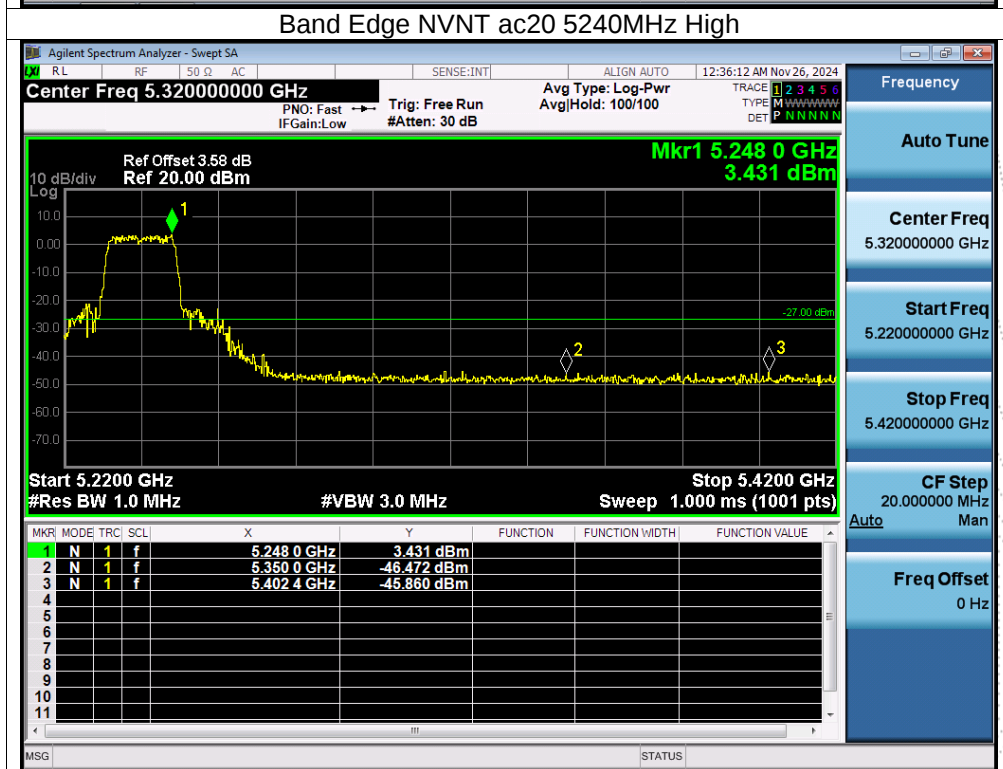
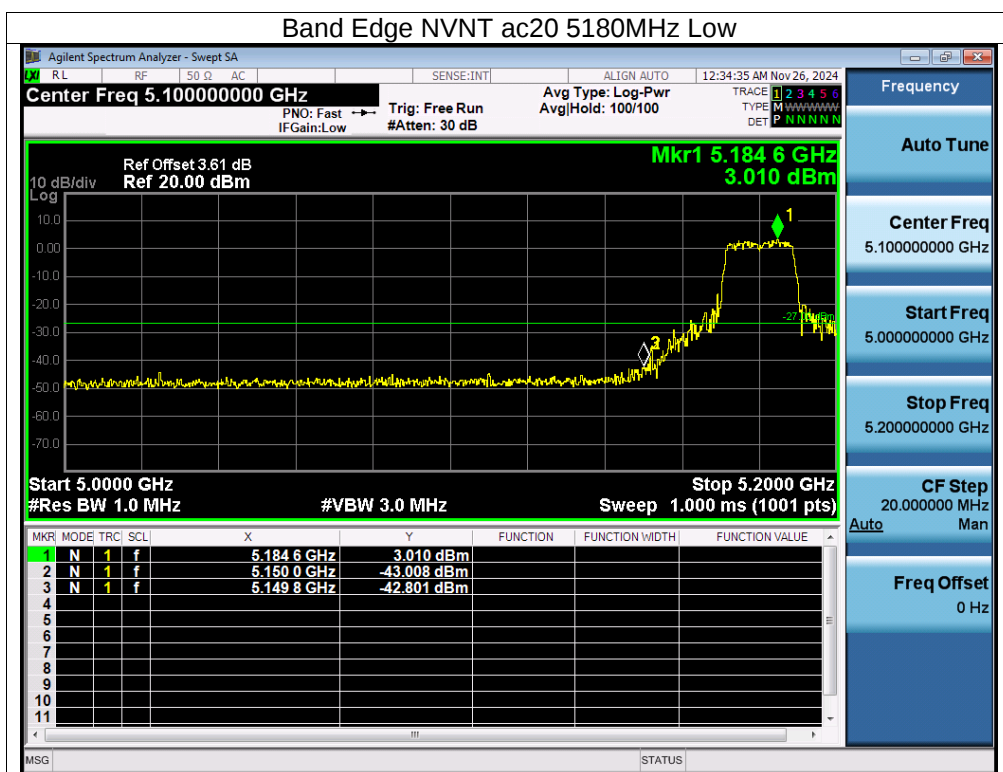
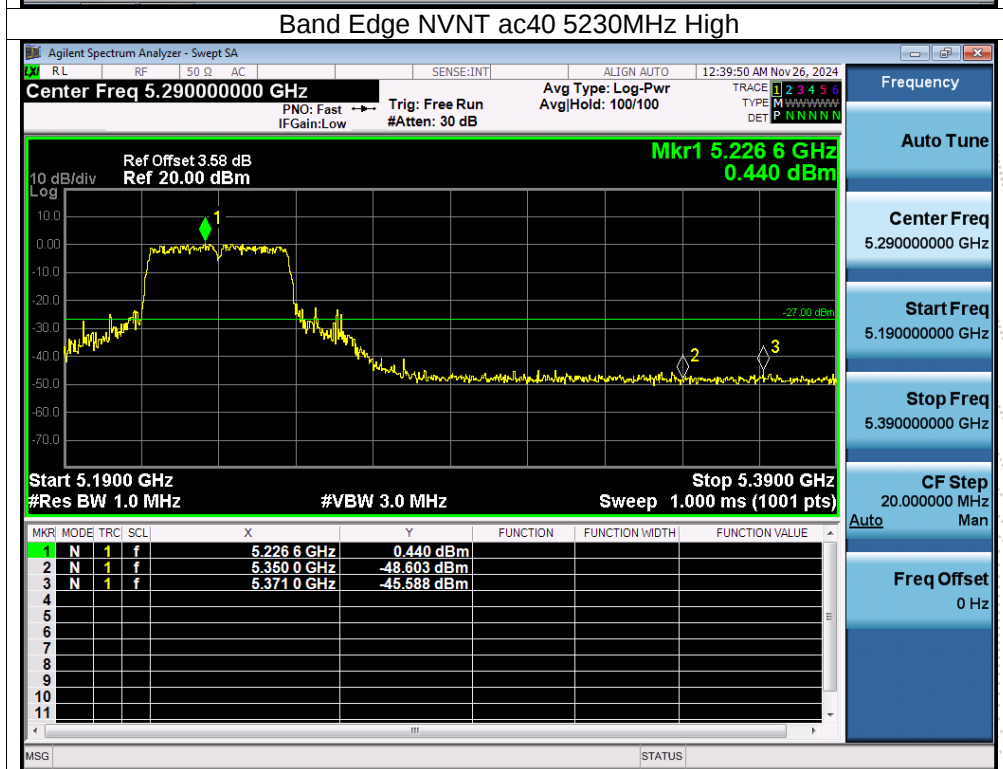
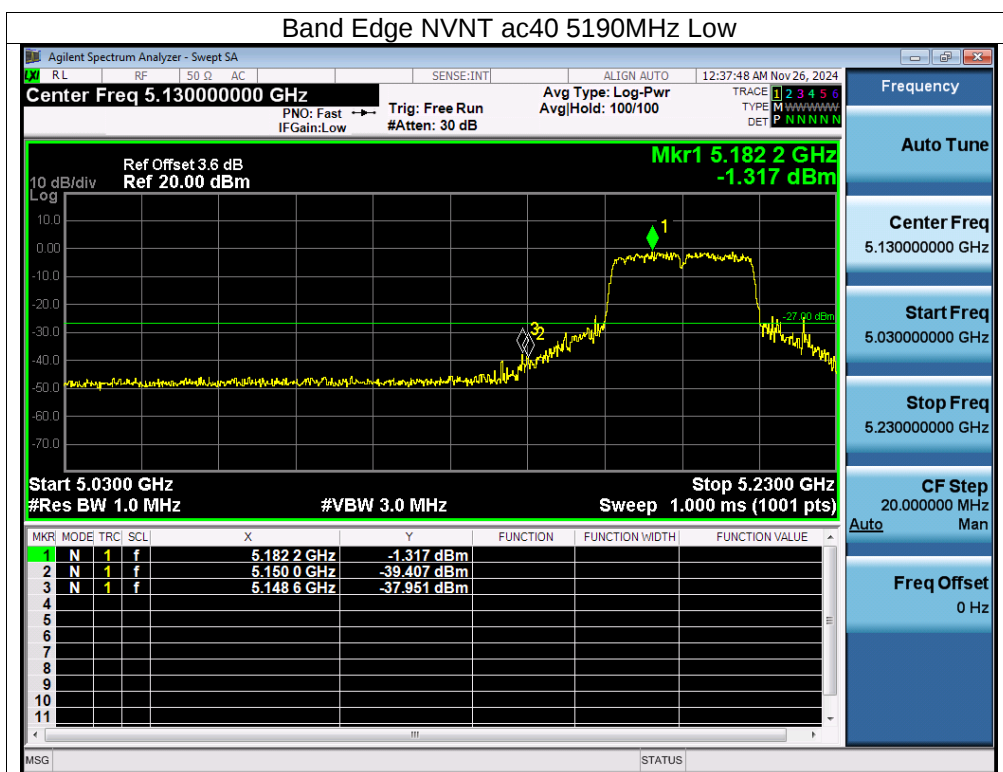
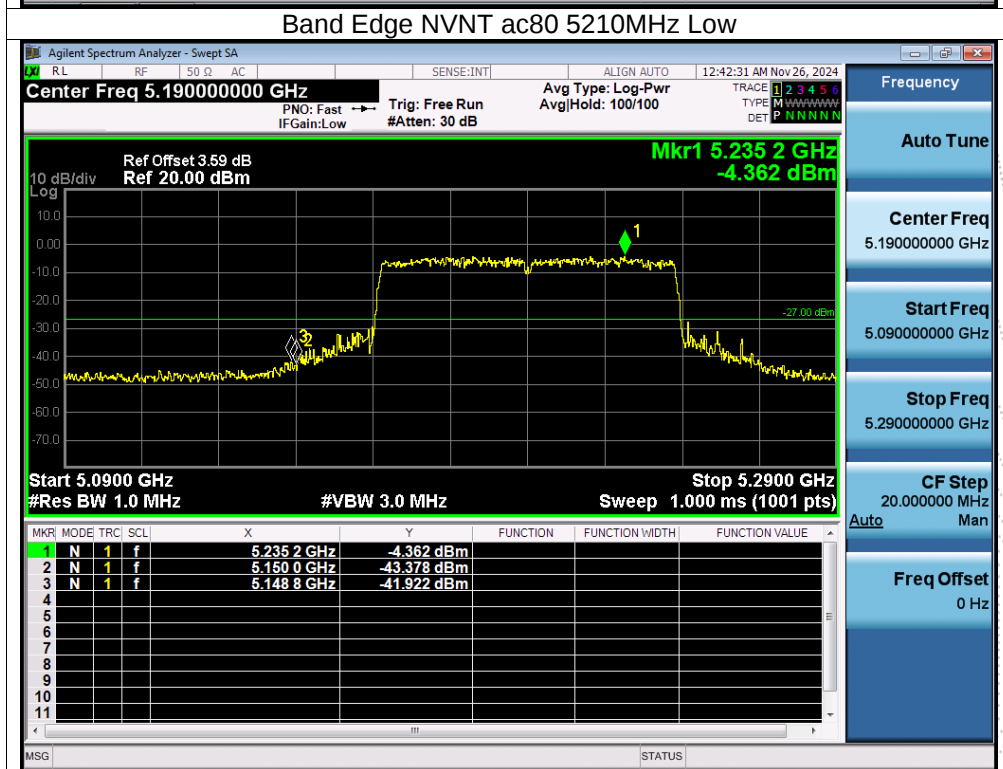
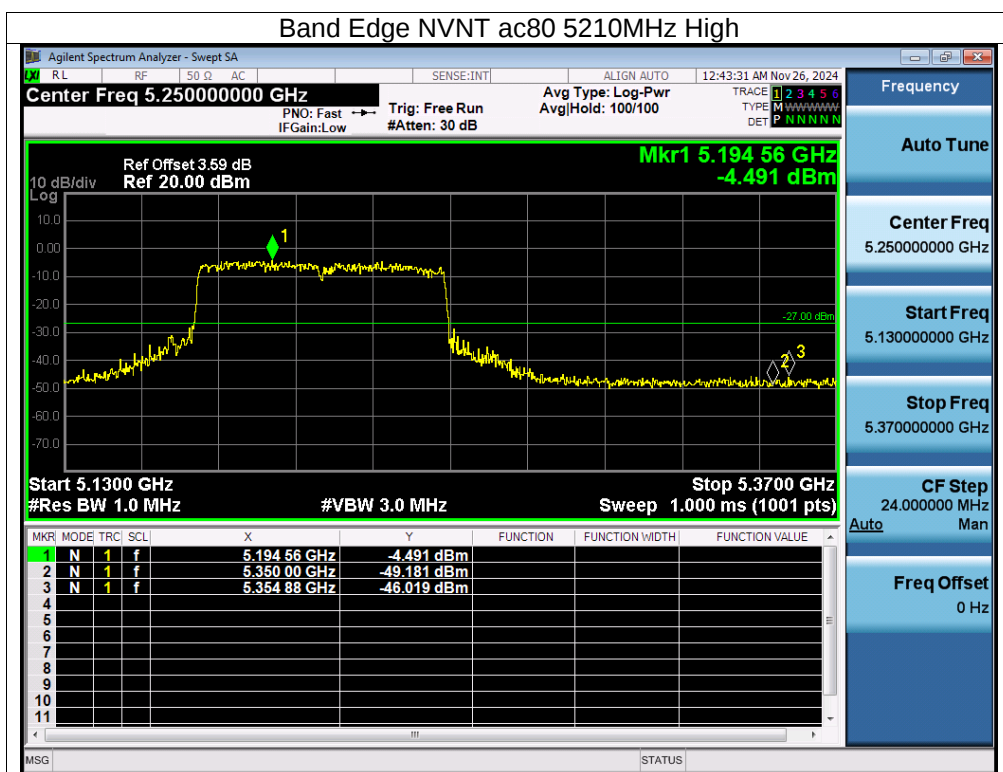


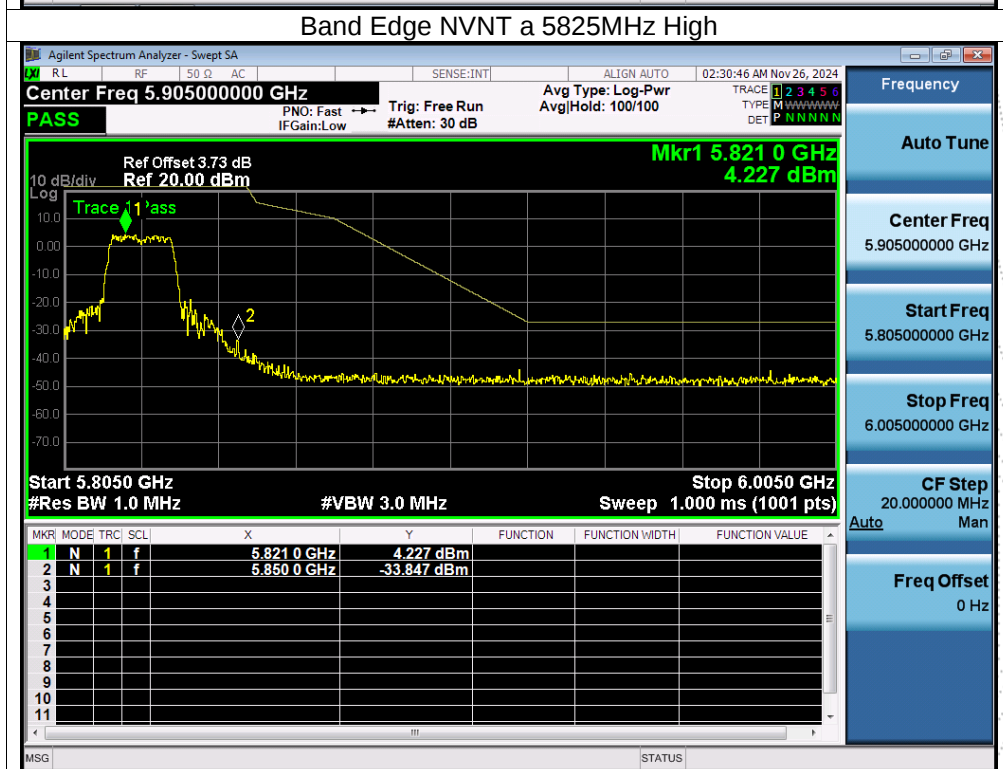
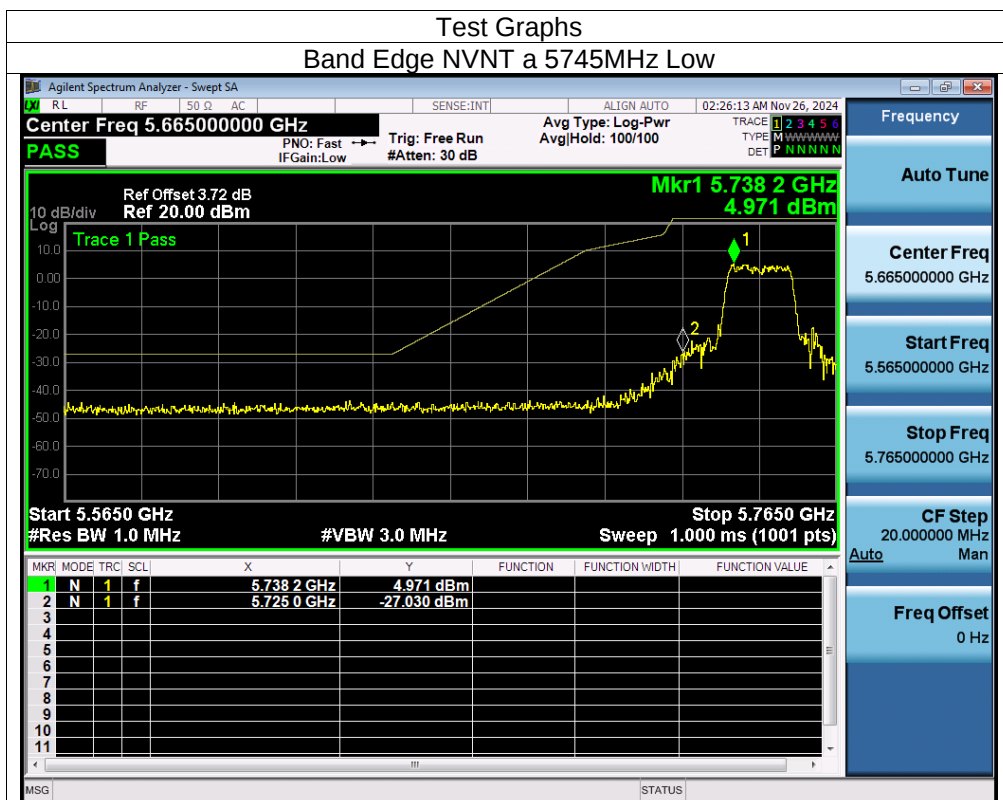


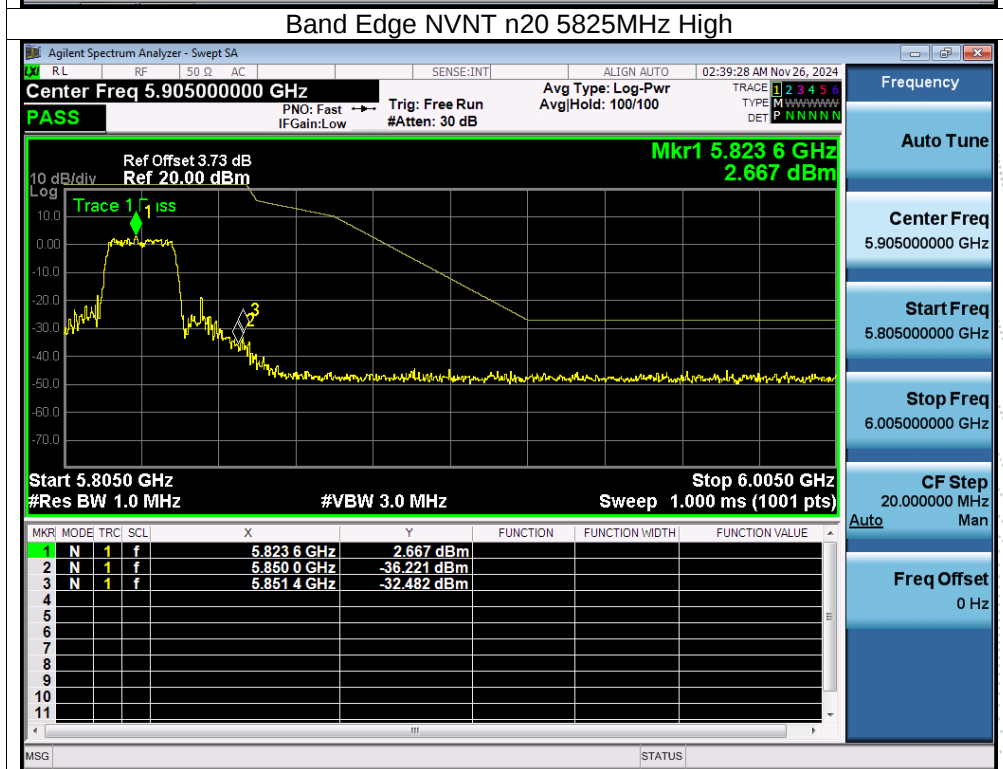
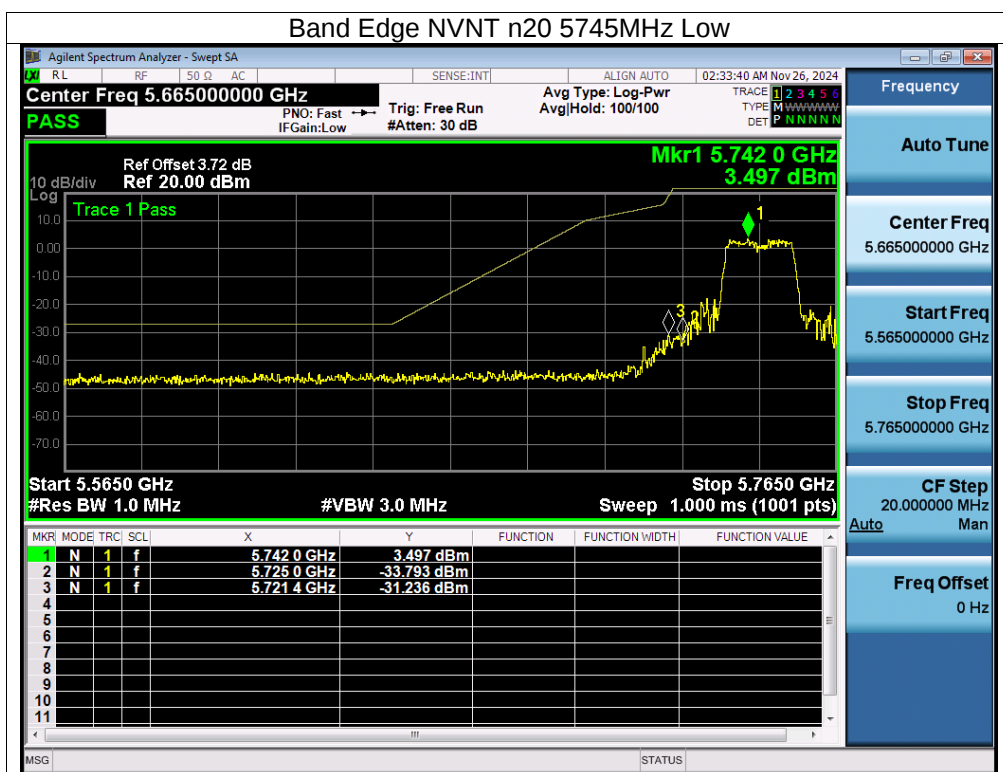


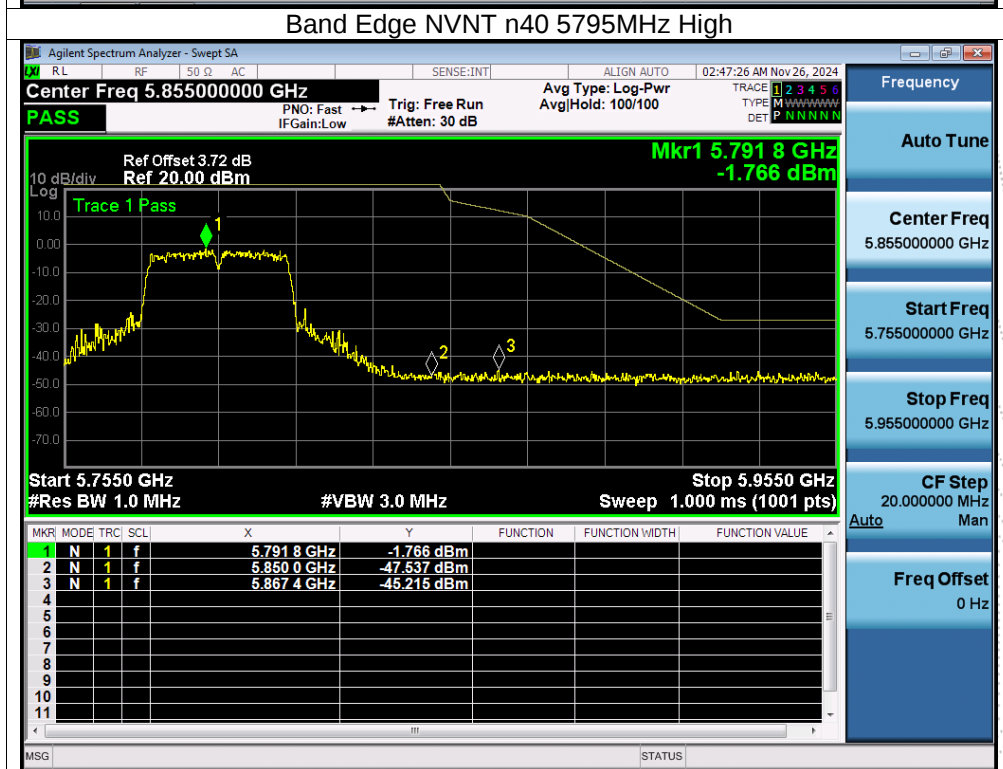
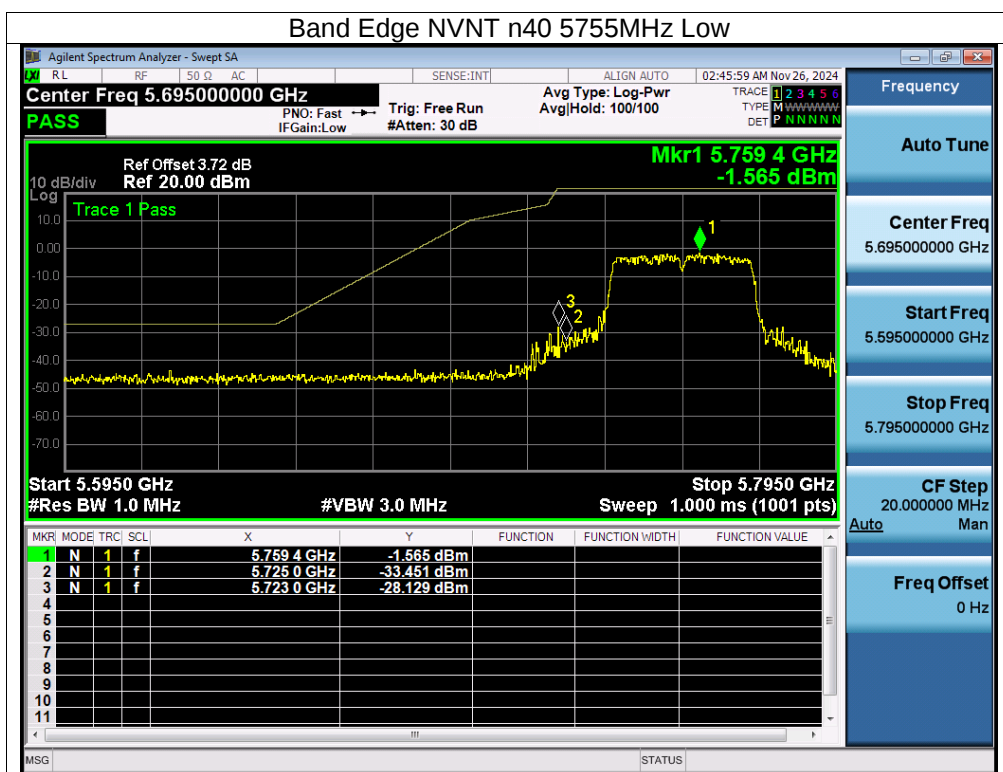


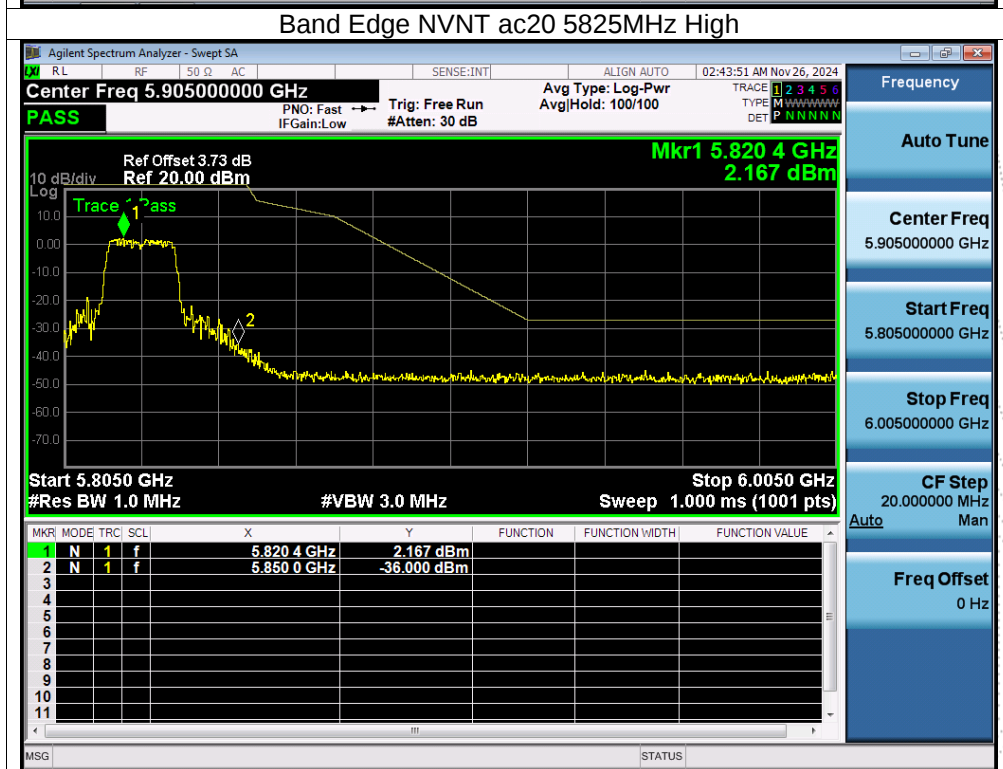
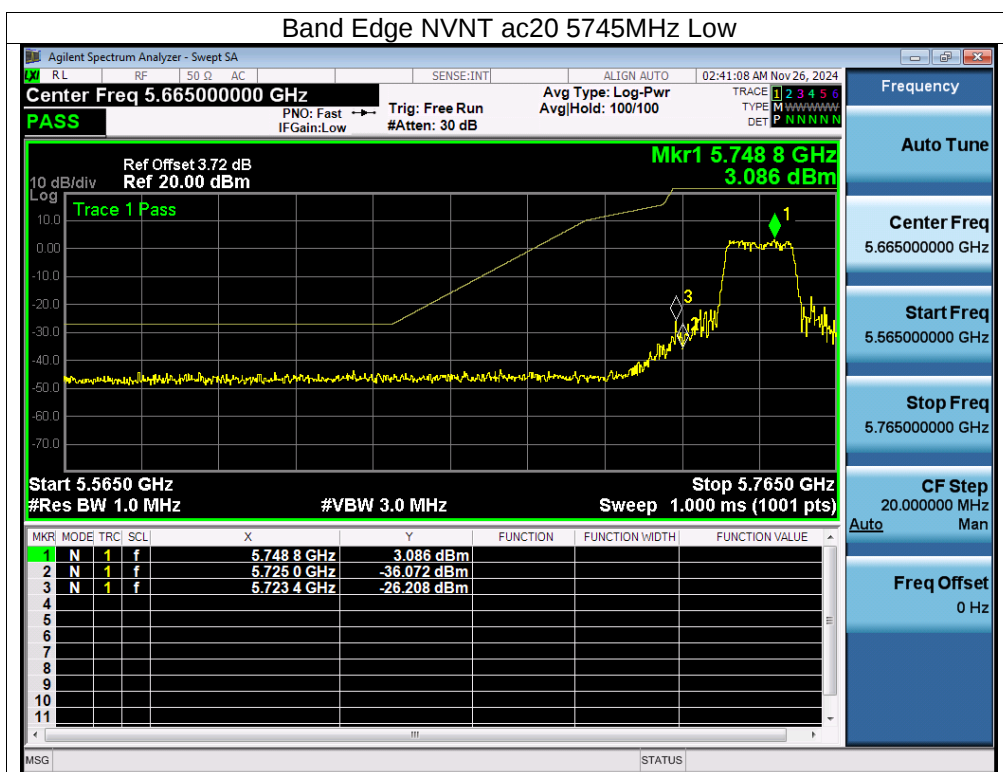


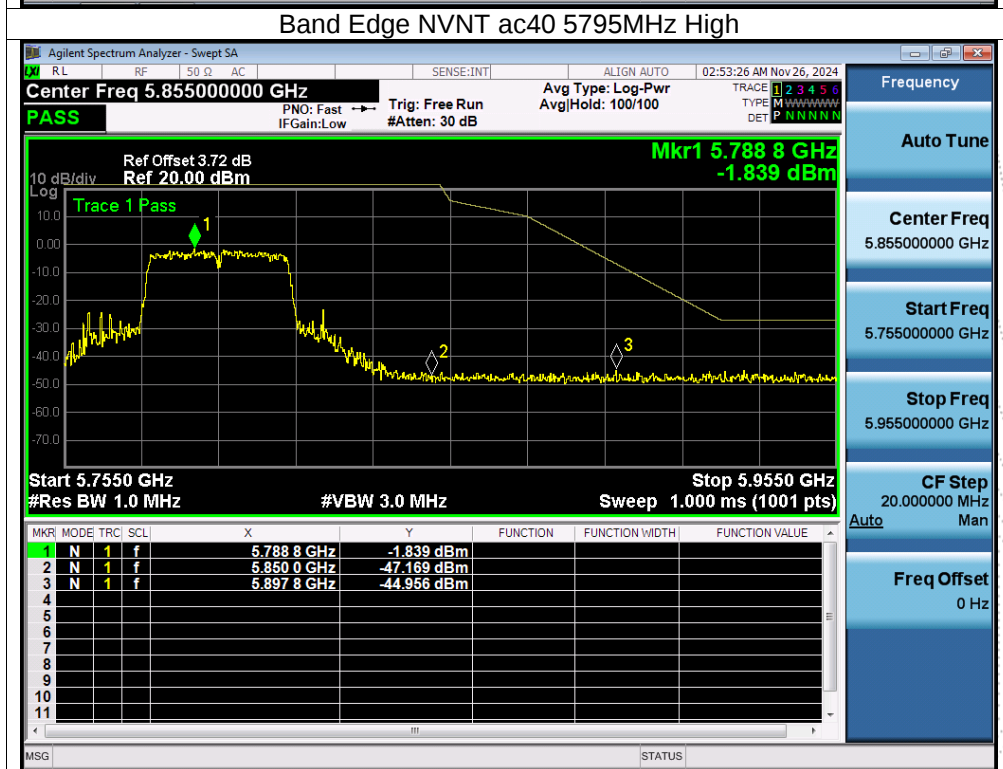
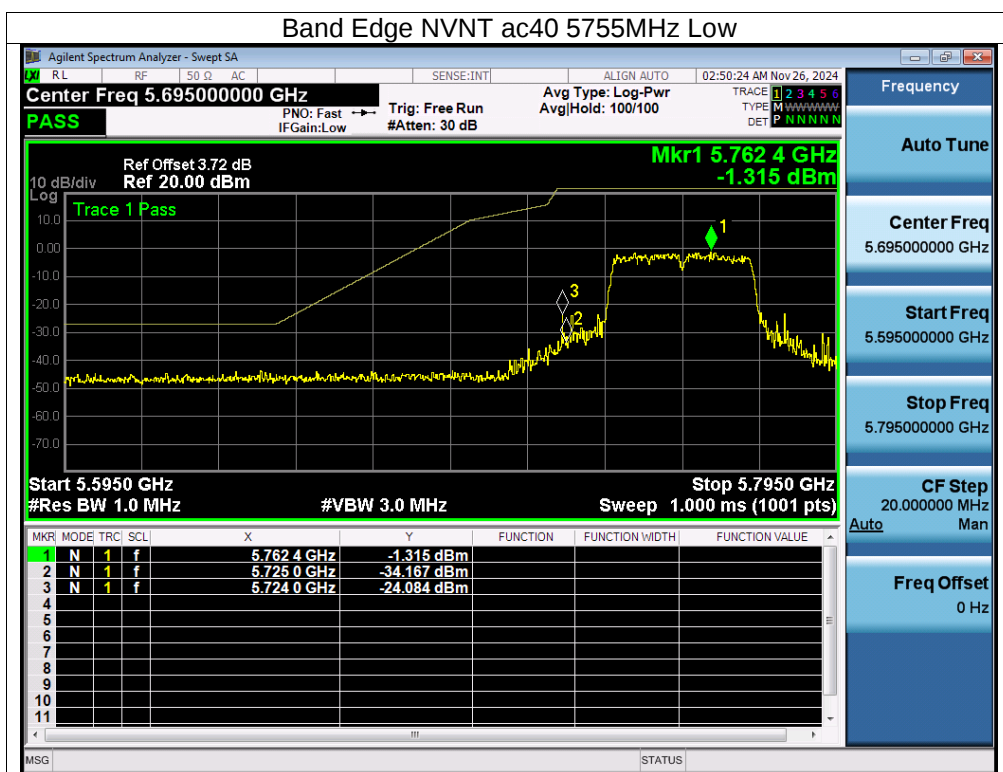


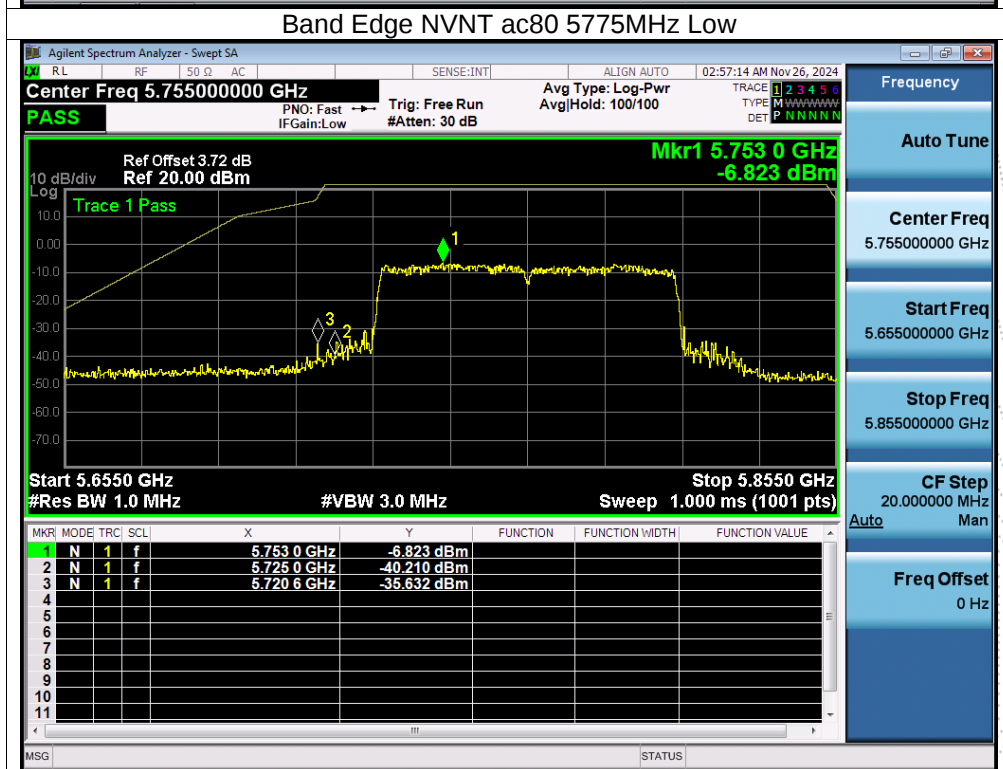
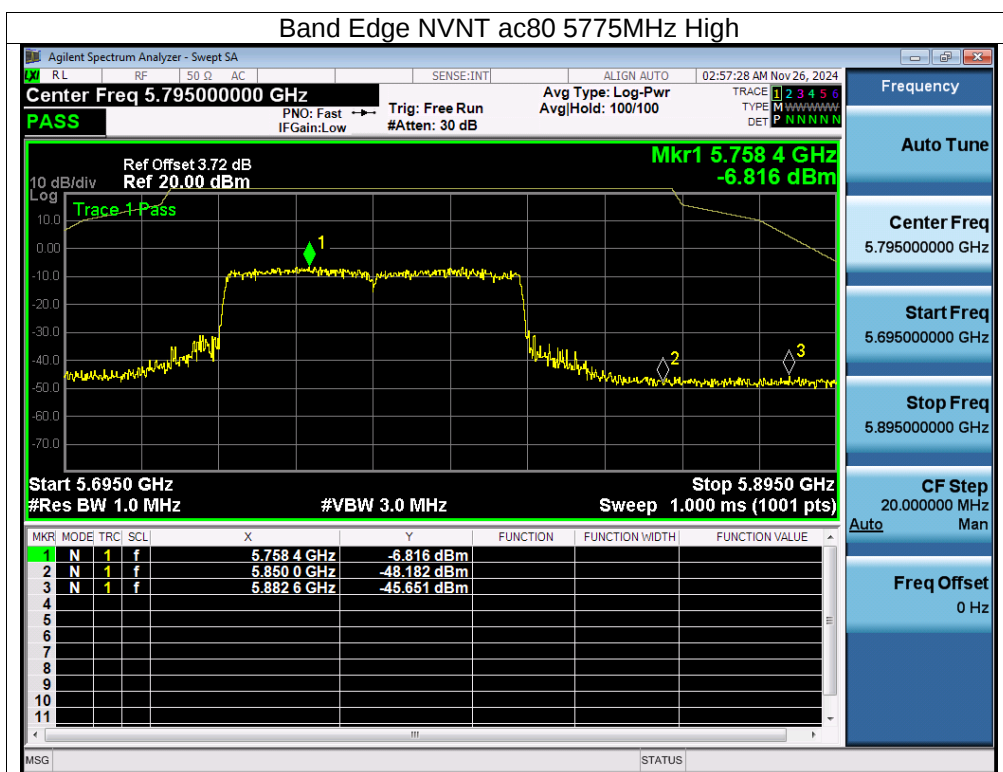












12. Spurious RF Conducted Emissions

12.1 Block Diagram Of Test Setup



12.2 Limit

Undesirable emission limits. Except as shown in paragraph (b)(7) of this section, the maximum emissions outside of the frequency bands of operation shall be attenuated in accordance with the following limits:

(1) For transmitters operating in the 5.15-5.25 GHz band: All emissions outside of the 5.15-5.35 GHz band shall not exceed an e.i.r.p. of -27 dBm/MHz.

(2) For transmitters operating in the 5.725-5.85 GHz band(i) All emissions shall be limited to a level of -27 dBm/MHz at 75 MHz or more above or below the band edge increasing linearly to 10 dBm/MHz at 25 MHz above or below the band edge, and from 25 MHz above or below the band edge increasing linearly to a level of 15.6 dBm/MHz at 5 MHz above or below the band edge, and from 5 MHz above or below the band edge increasing linearly to a level of 27 dBm/MHz at the band edge..

12.3 Test Procedure

1. Check the calibration of the measuring instrument using either an internal calibrator or a known signal from an external generator.
2. Position the EUT without connection to measurement instrument. Turn on the EUT and connect its antenna terminal to measurement instrument via a low loss cable. Then set it to any one measured frequency within its operating range, and make sure the instrument is operated in its linear range.
3. Set RBW of spectrum analyzer to 1 MHz with a convenient frequency span.
4. Measure the highest amplitude appearing on spectral display and set it as a reference level. Plot the graph with marking the highest point and edge frequency.
5. Repeat above procedures until all measured frequencies were complete.

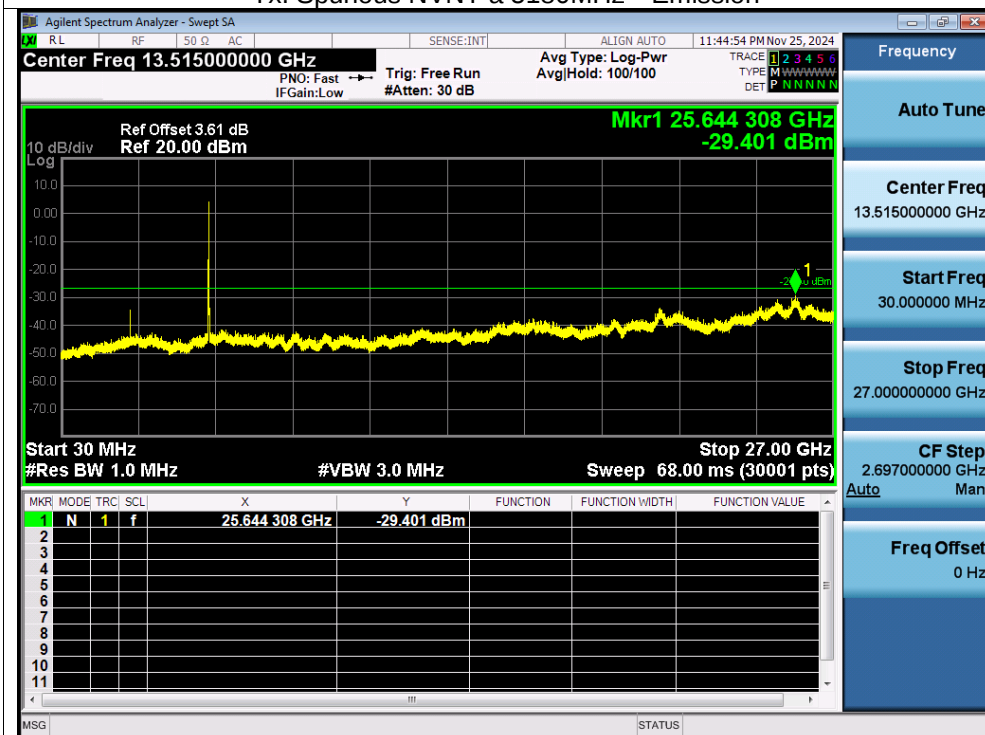
12.4 Test Result

Remark: The measurement frequency range is from 9KHz to the 10th harmonic of the fundamental frequency. The lowest, middle and highest channels are tested to verify the spurious emissions and band edge measurement data.

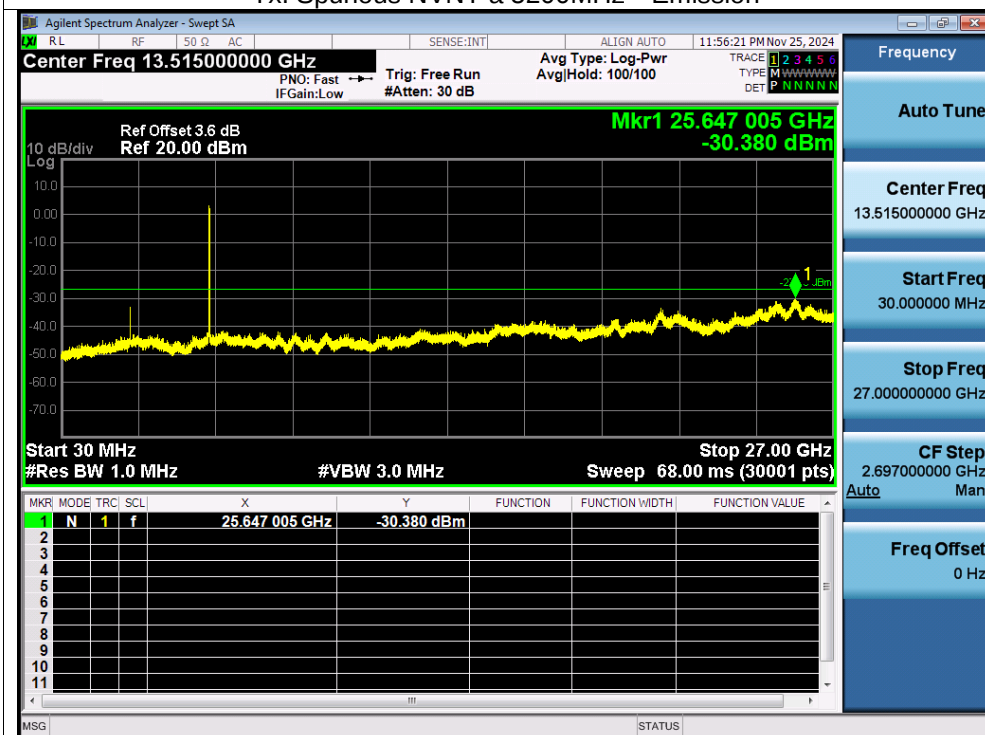
About: 26.5GHz-40GHz, The amplitude of spurious emissions which are attenuated by more than 20dB below the permissible value has no need to be reported.

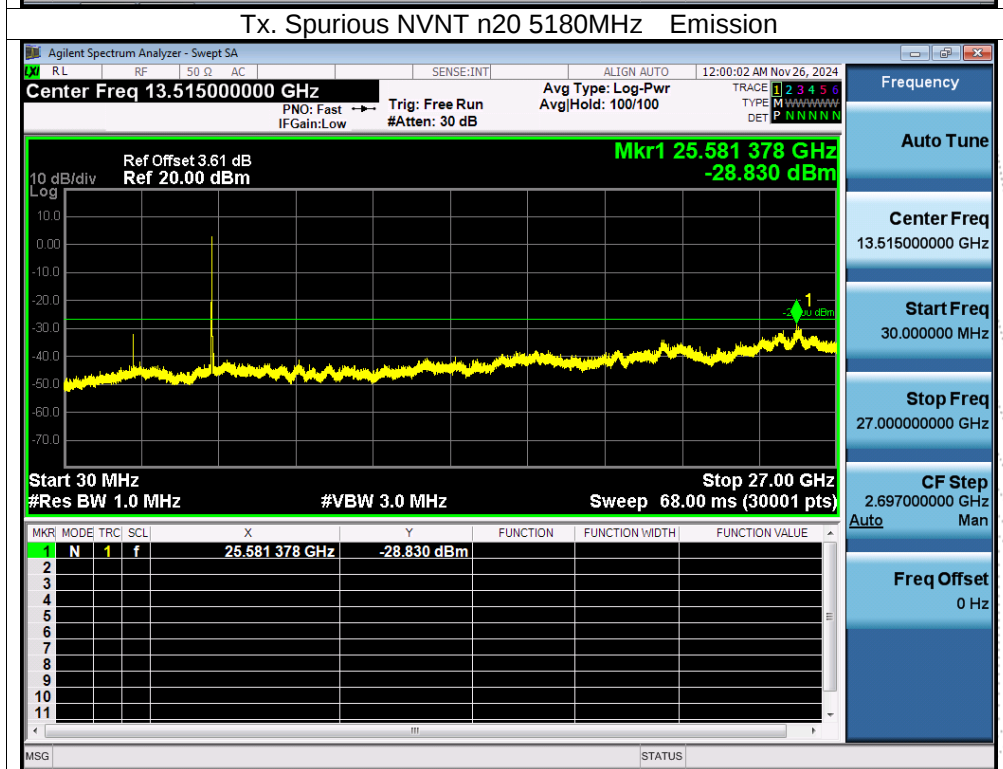
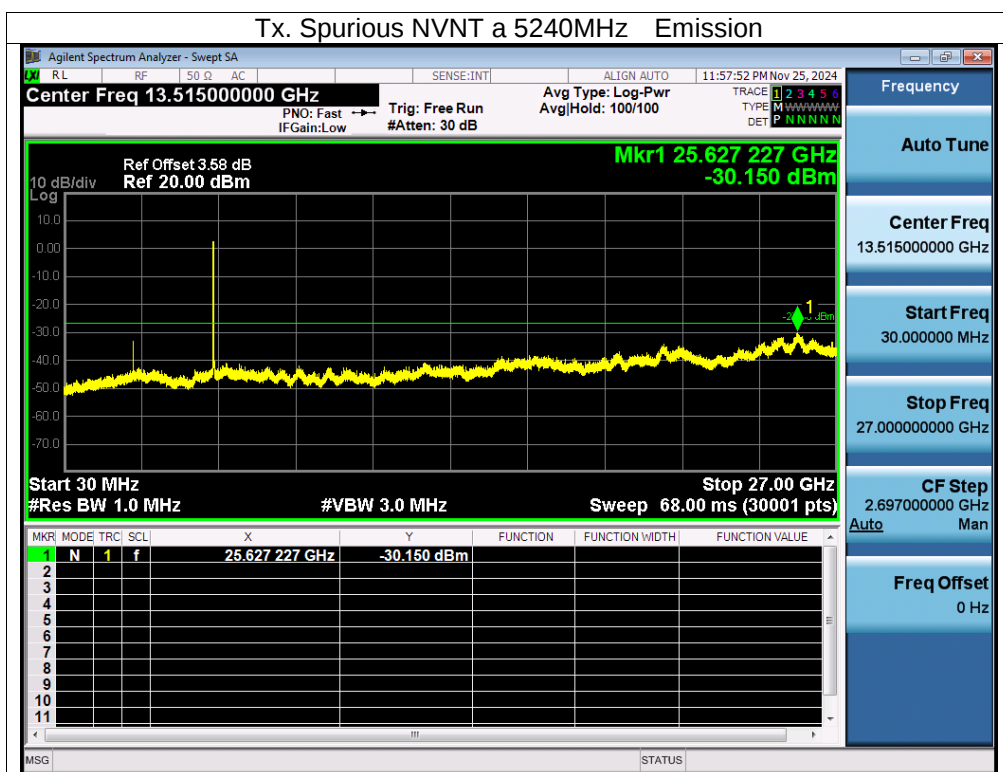
Test Graphs

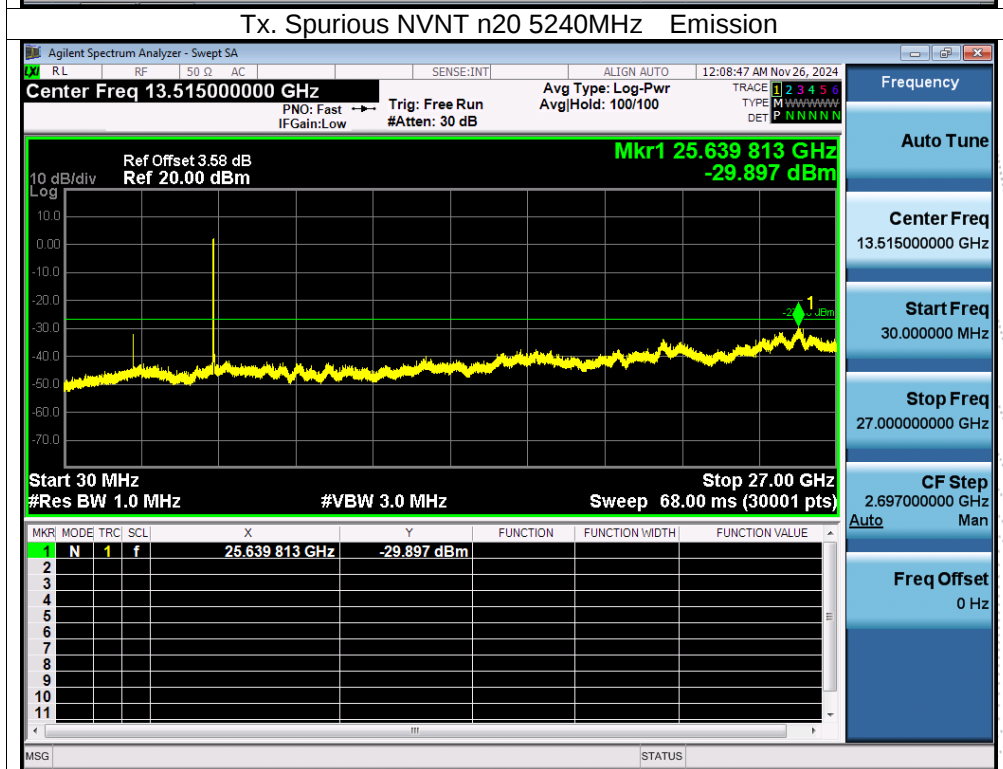
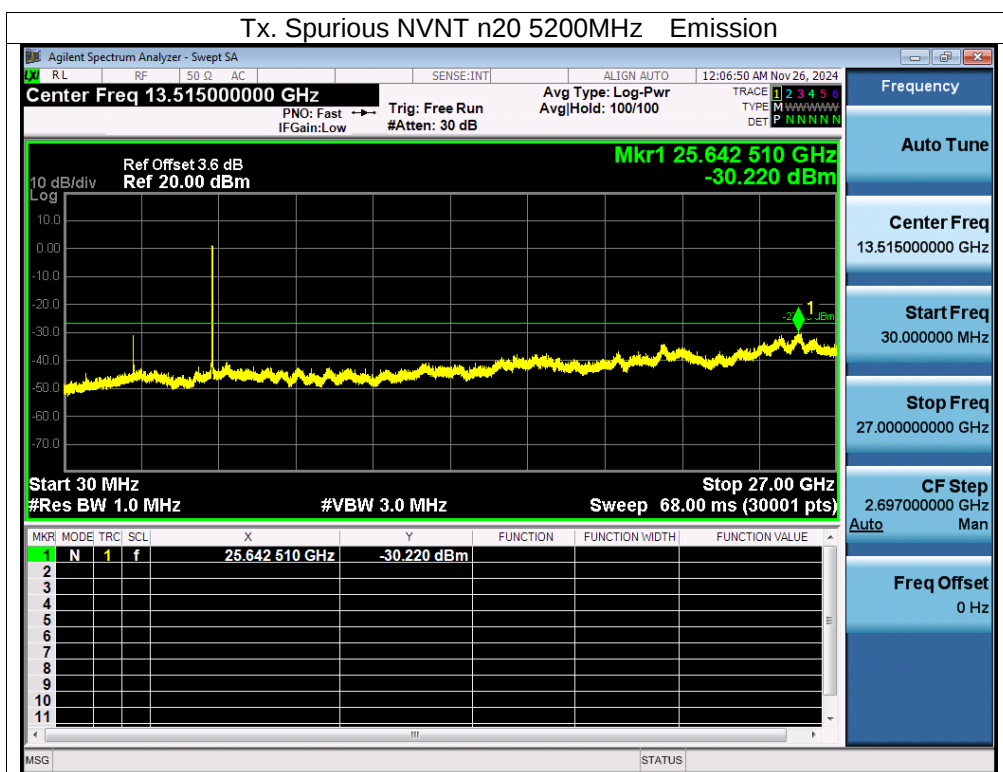
Tx. Spurious NVNT a 5180MHz Emission

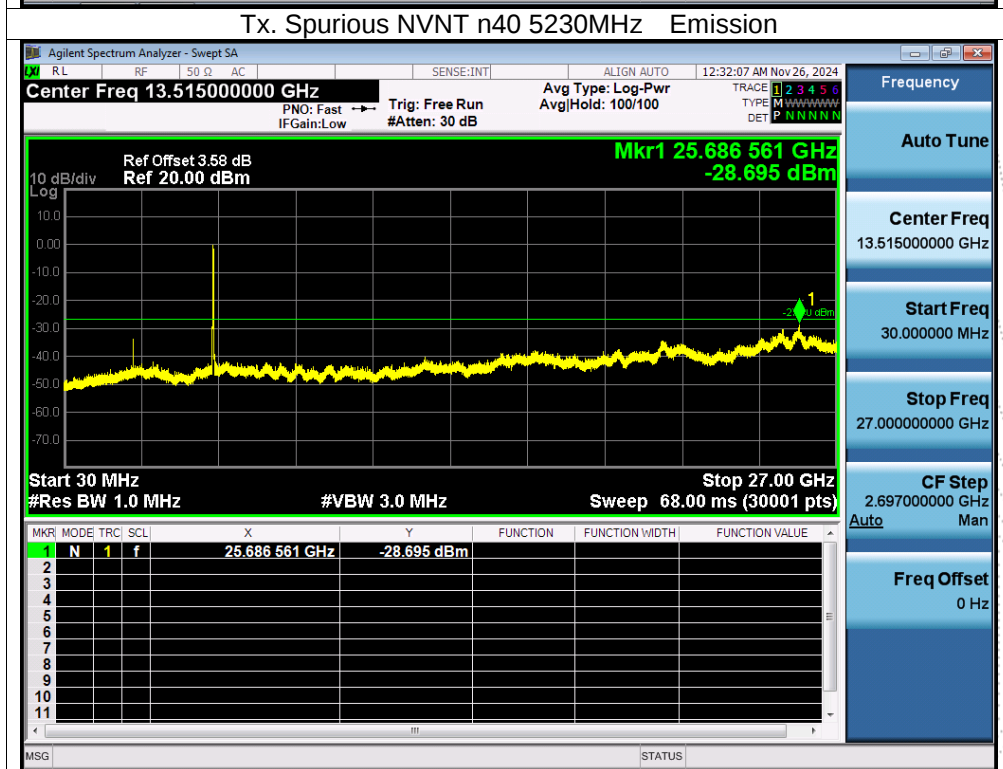
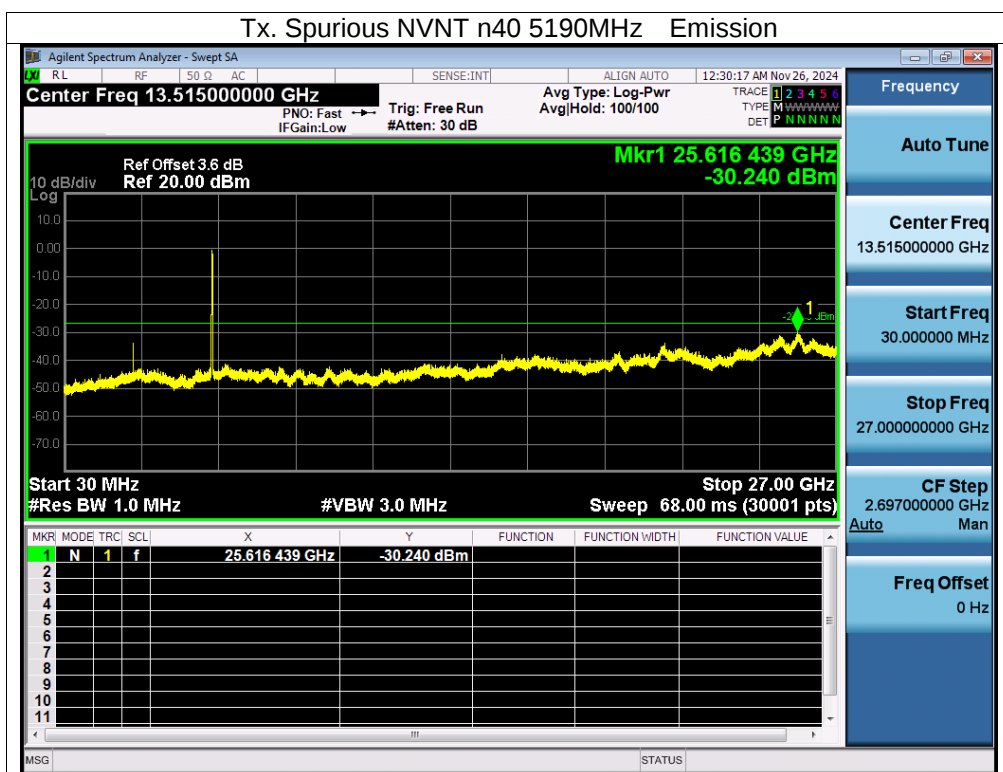


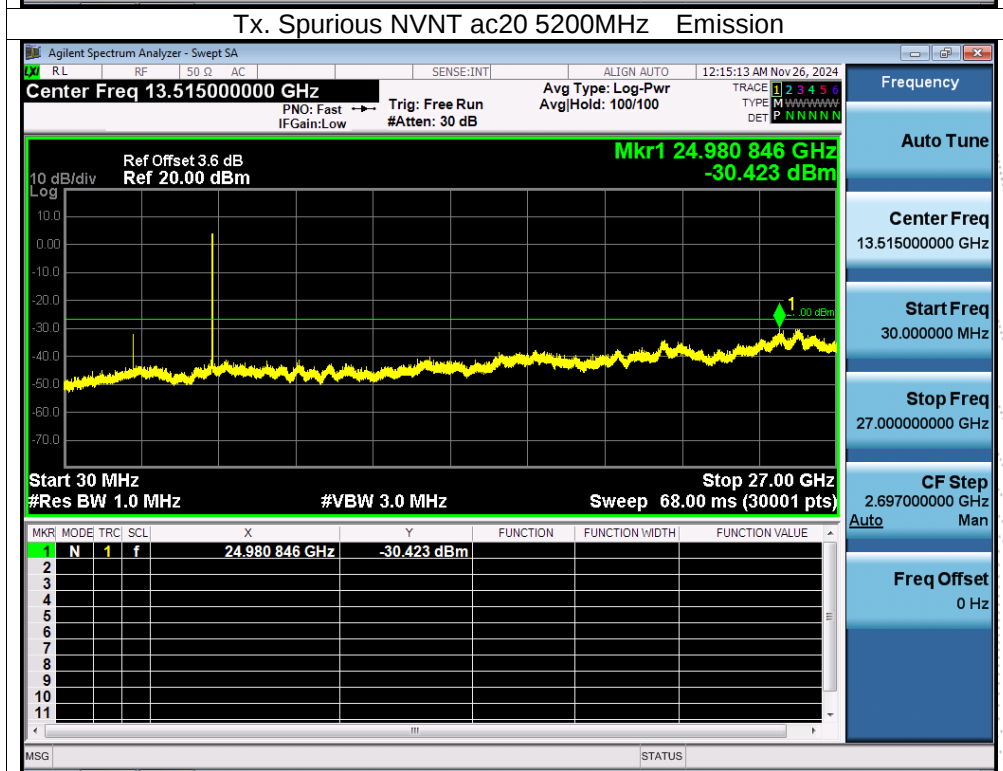
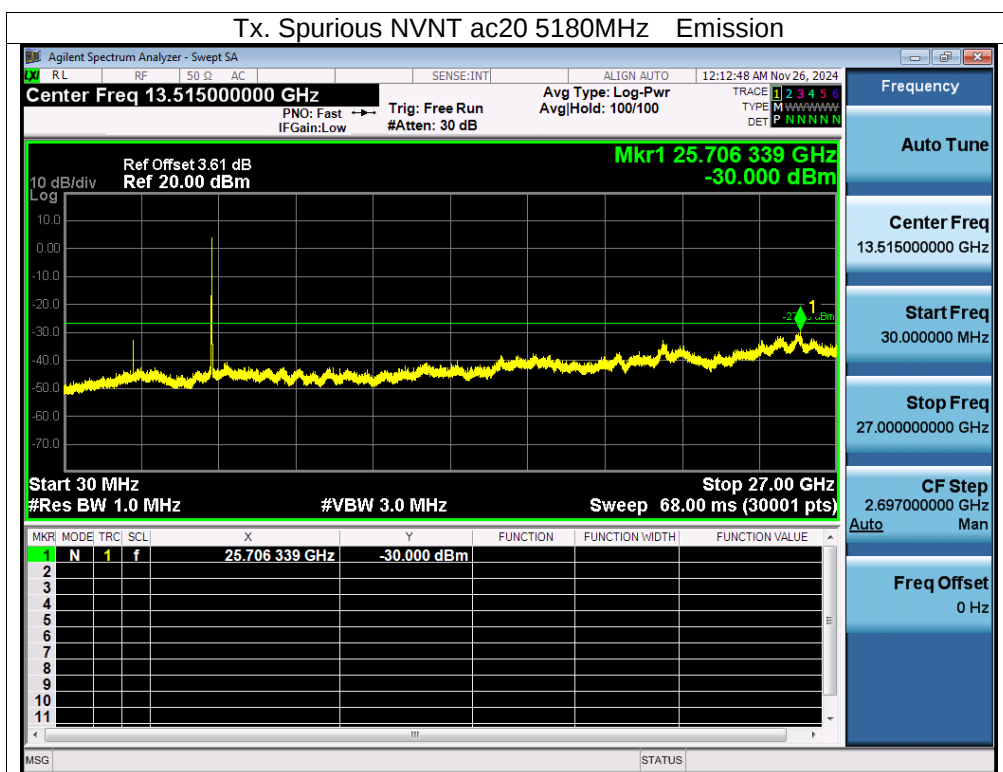
Tx. Spurious NVNT a 5200MHz Emission

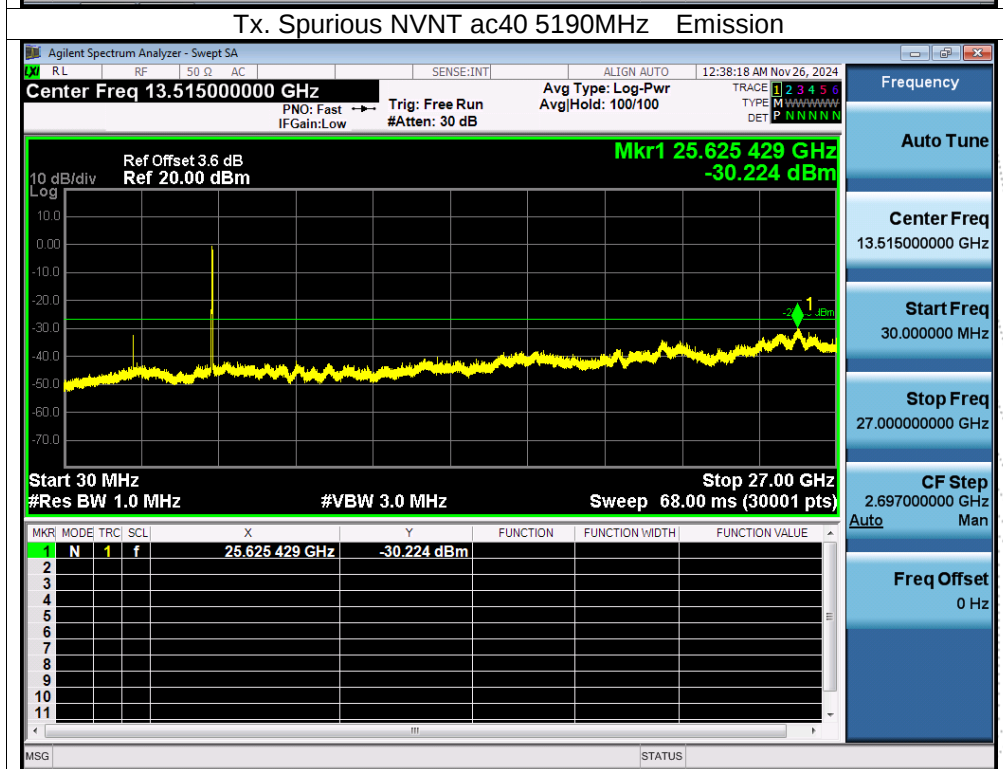
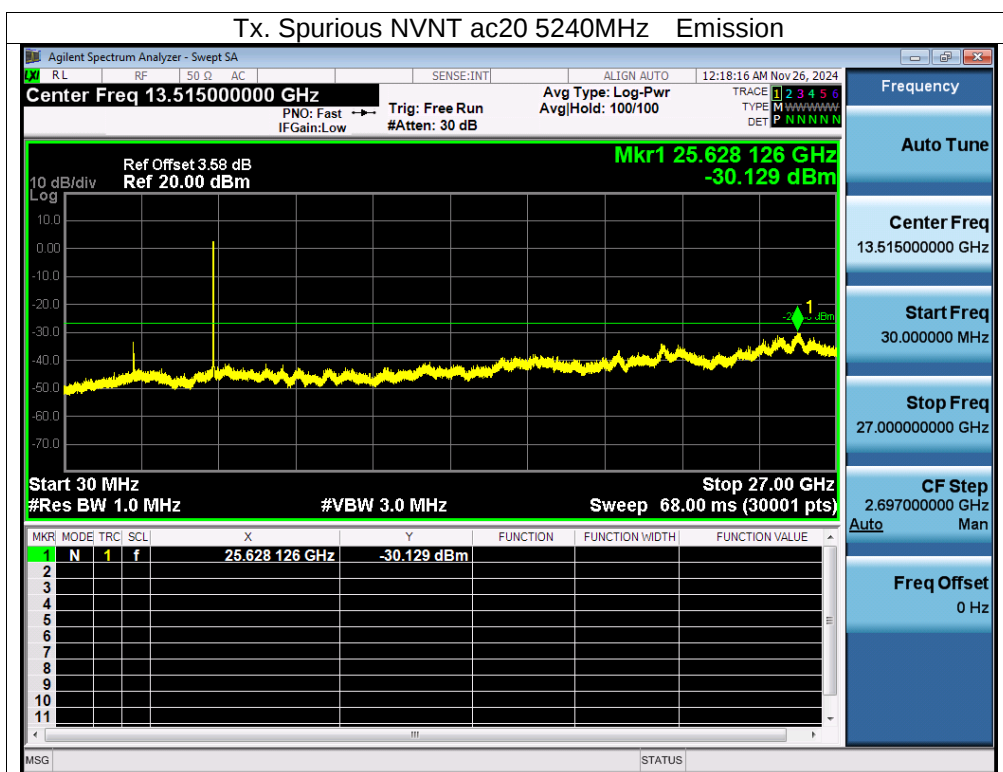


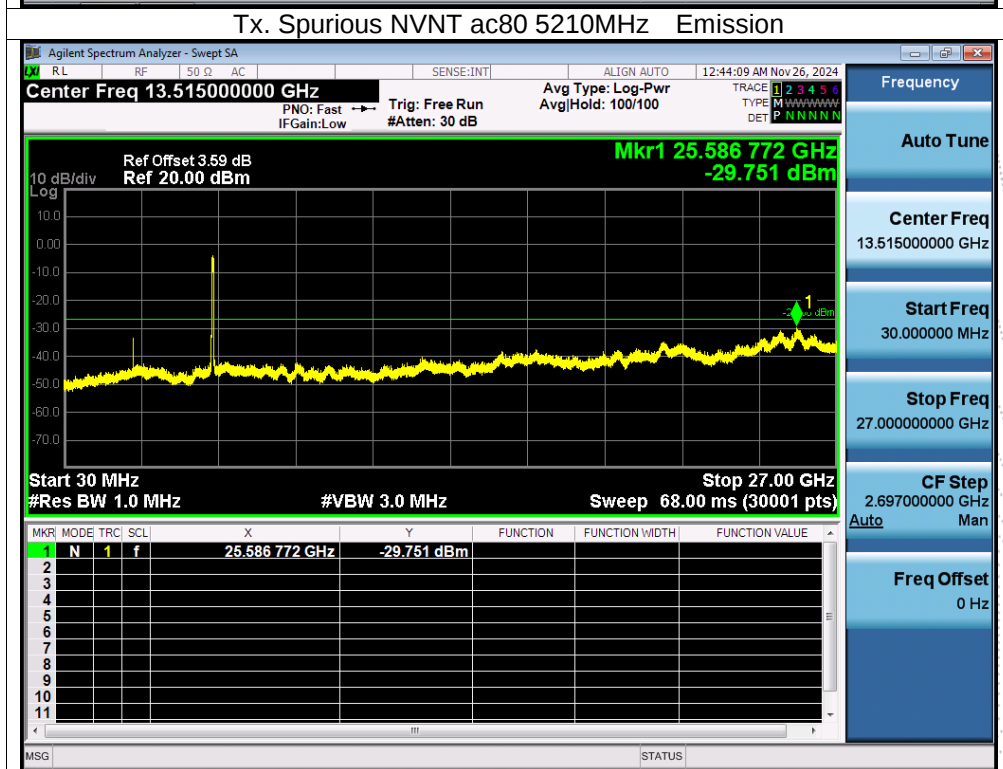
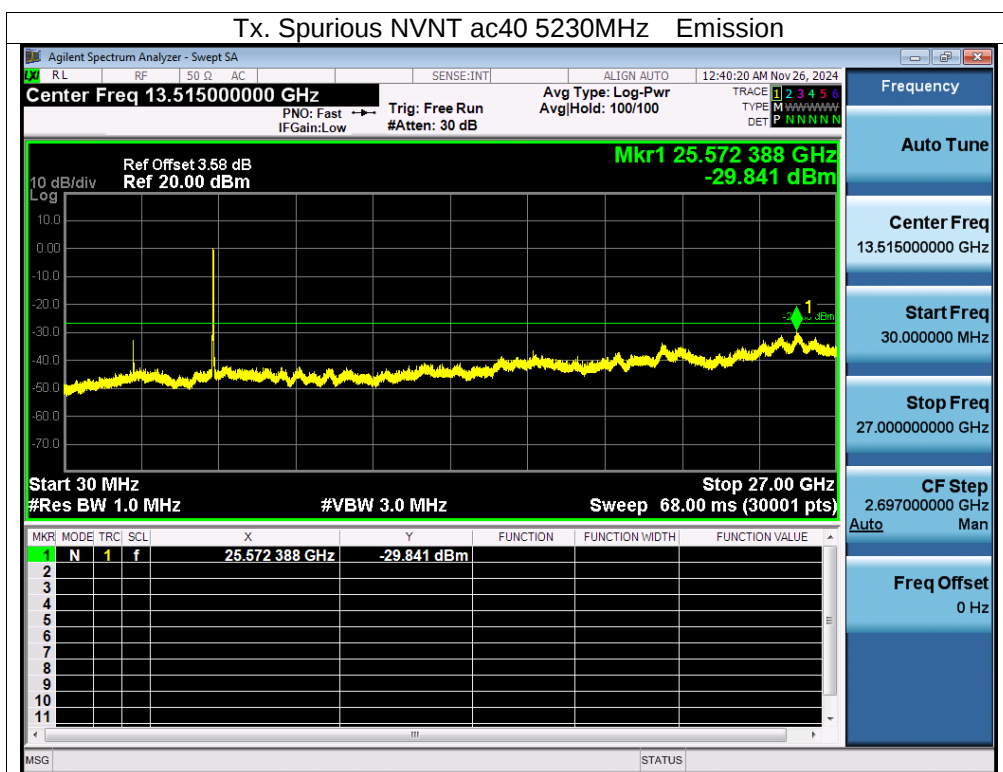






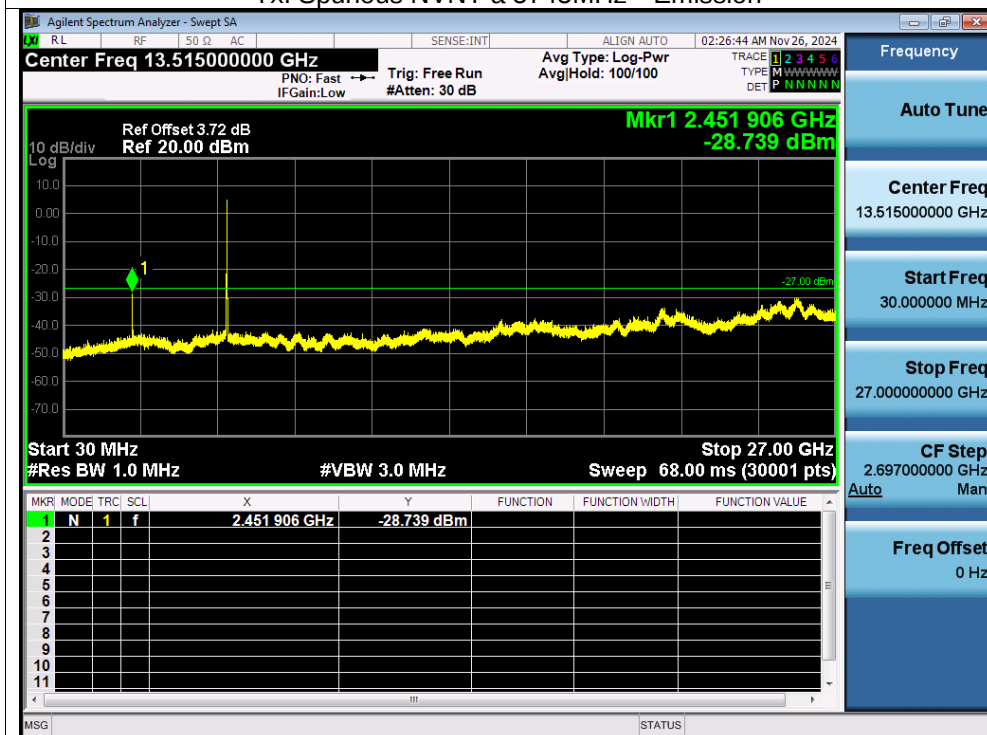




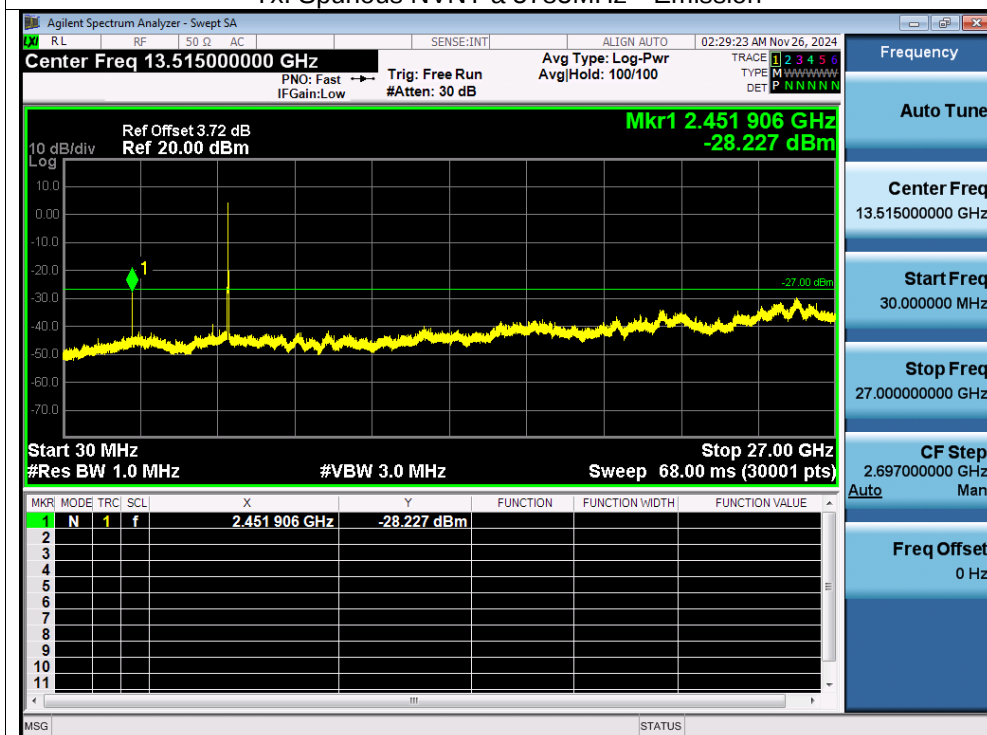


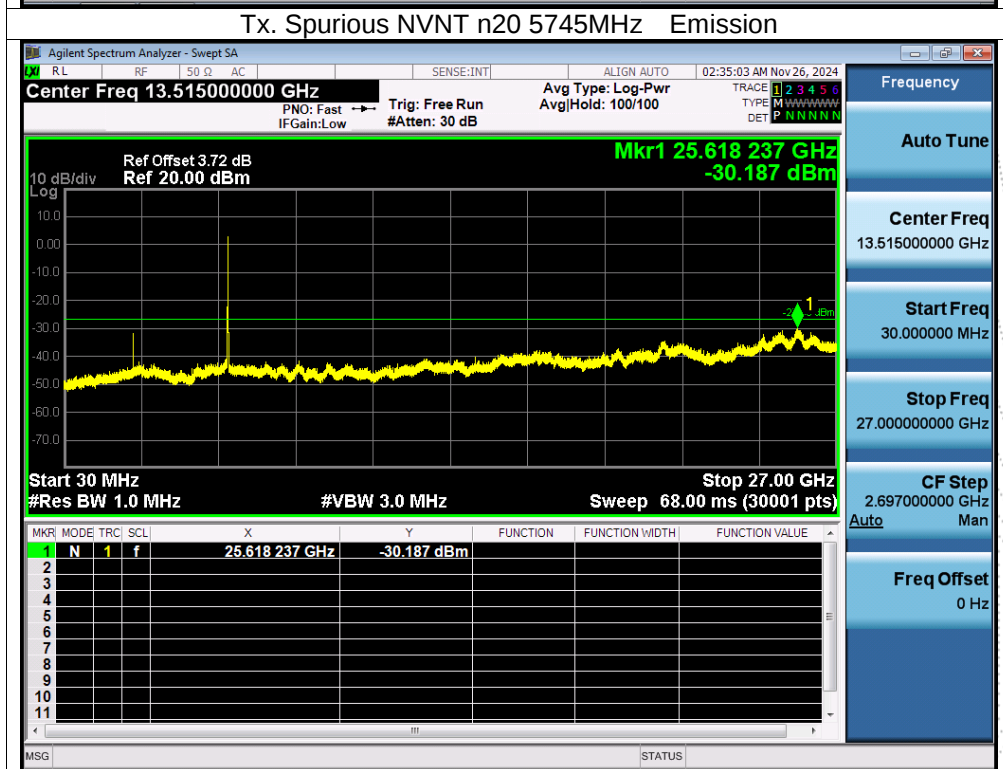
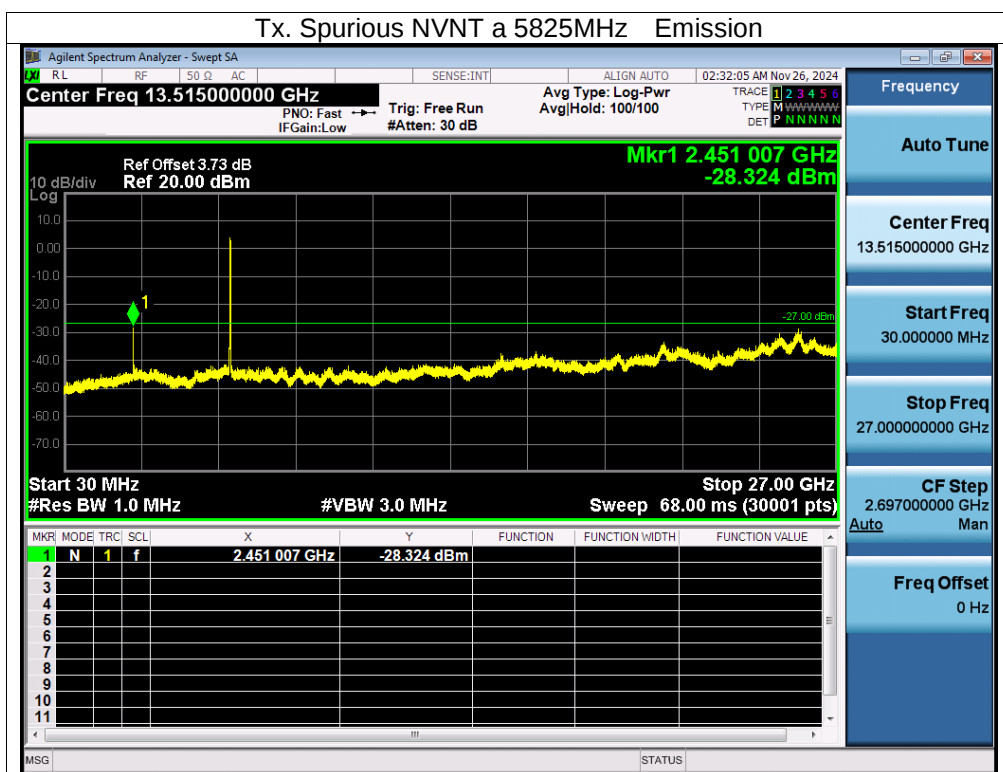
Test Graphs

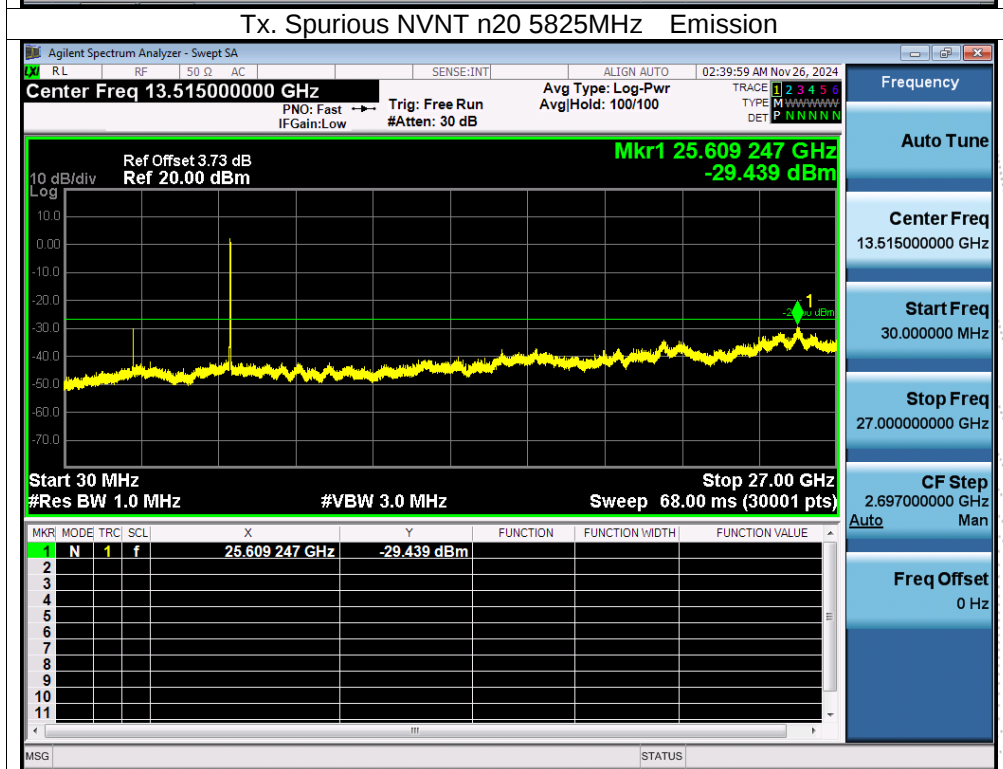
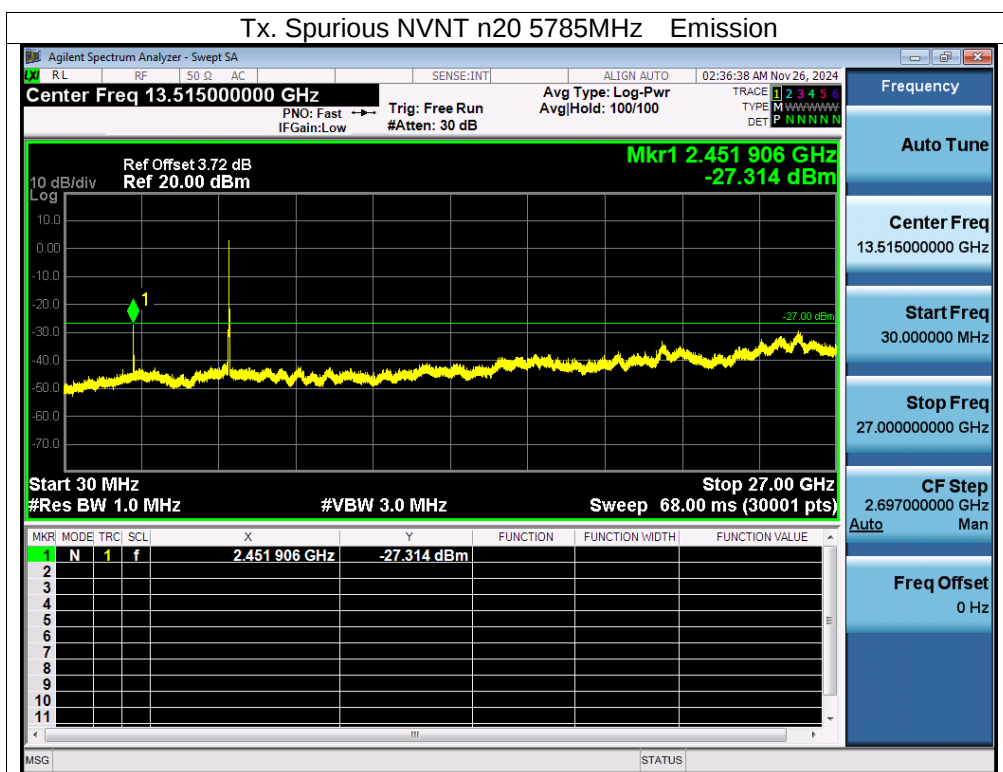
Tx. Spurious NVNT a 5745MHz Emission

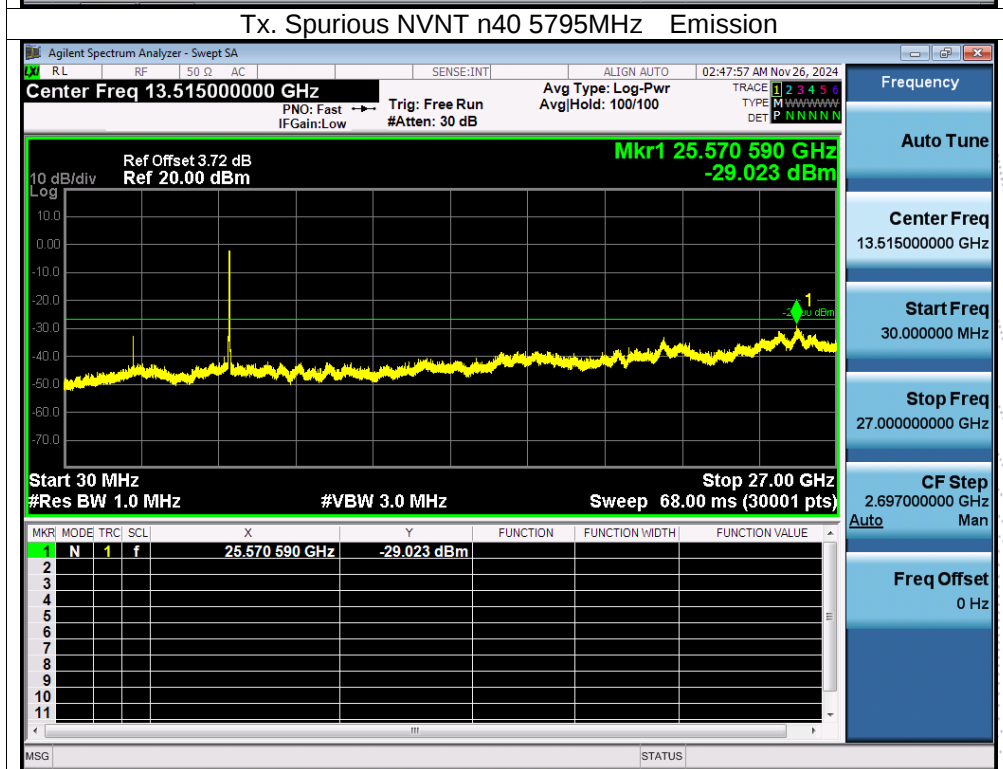
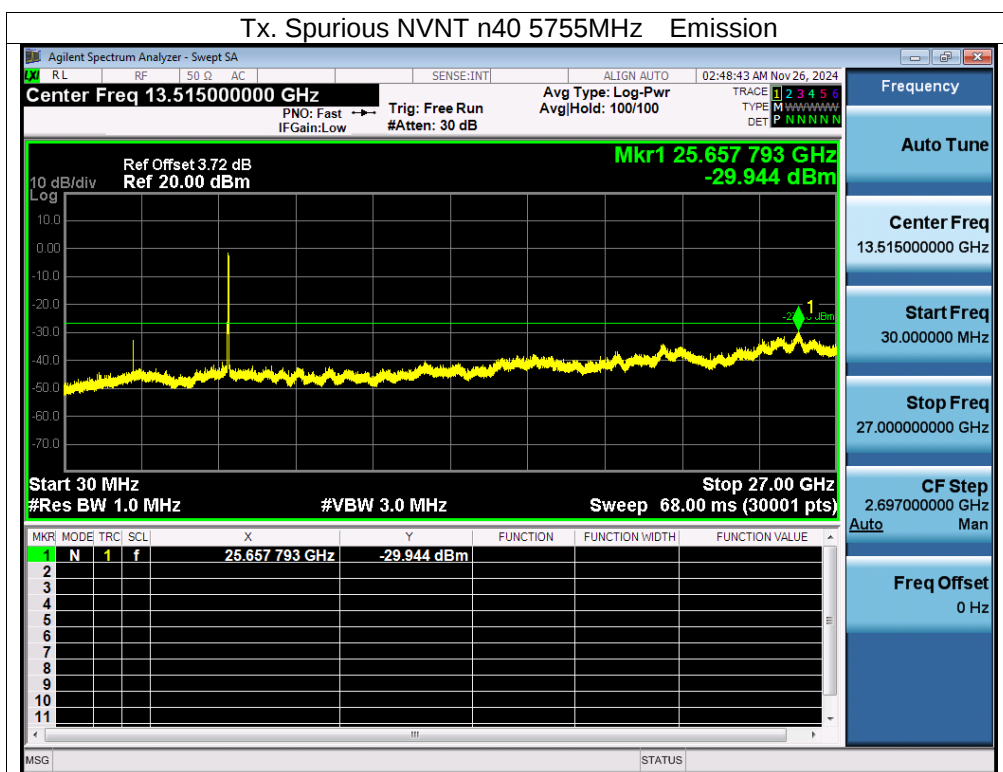


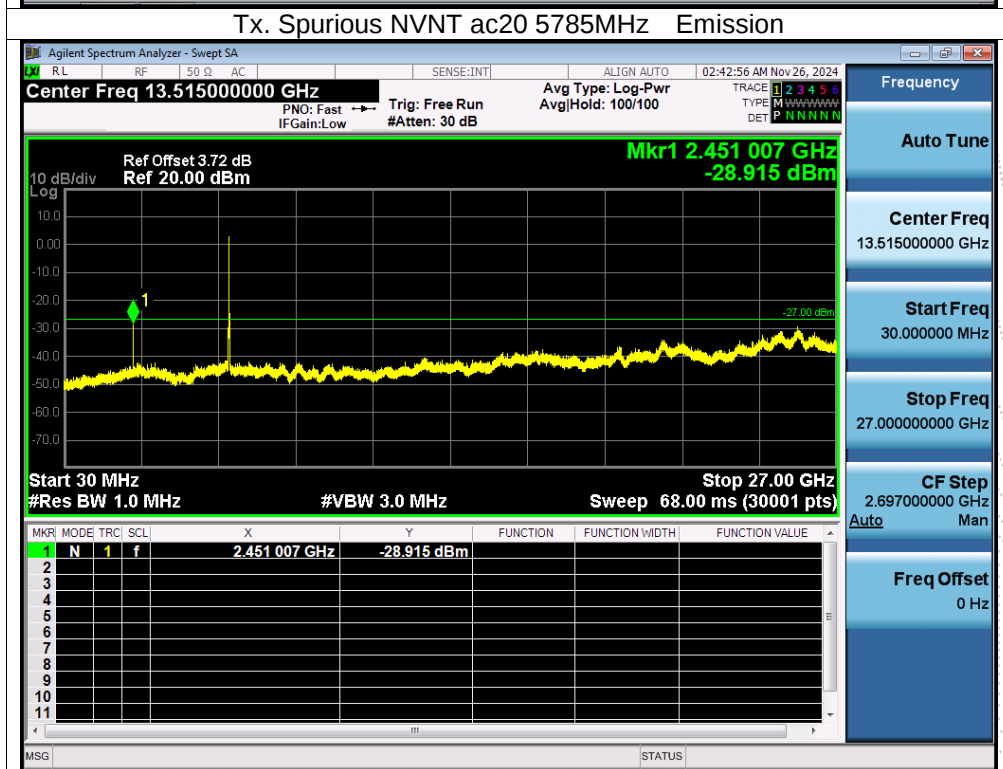
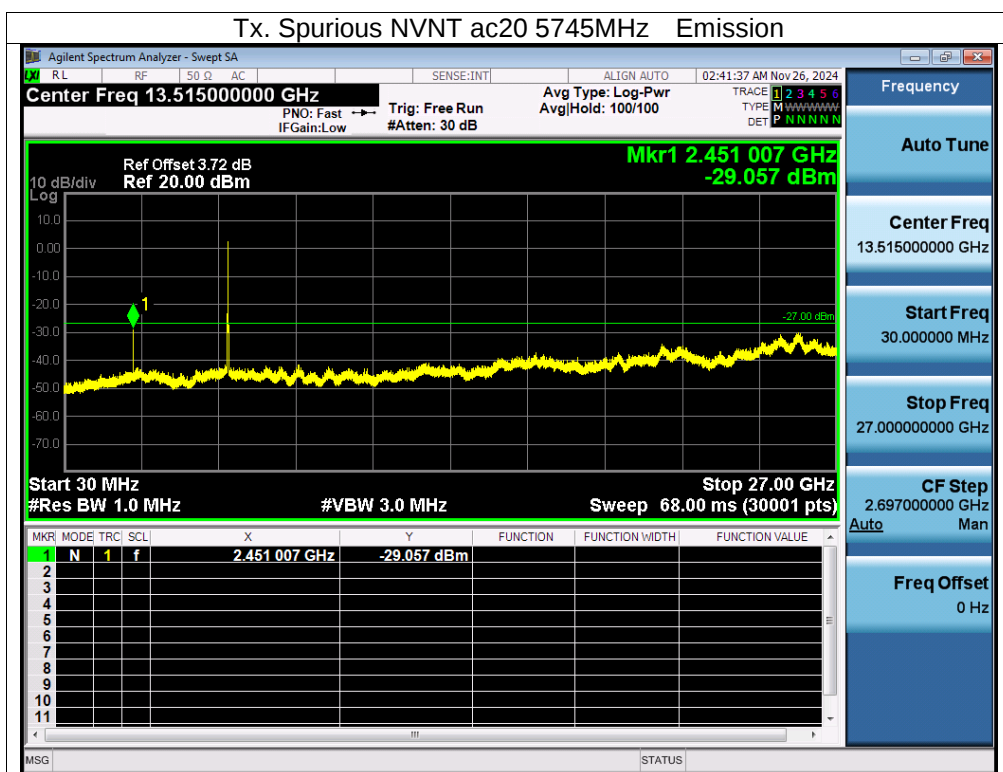
Tx. Spurious NVNT a 5785MHz Emission

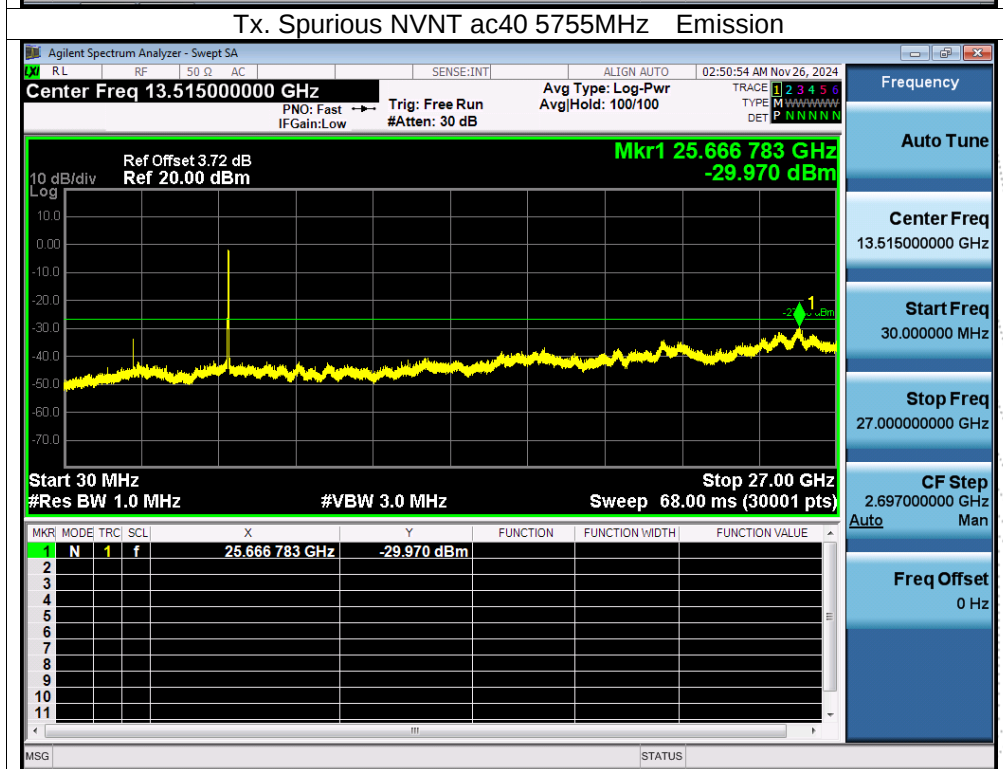
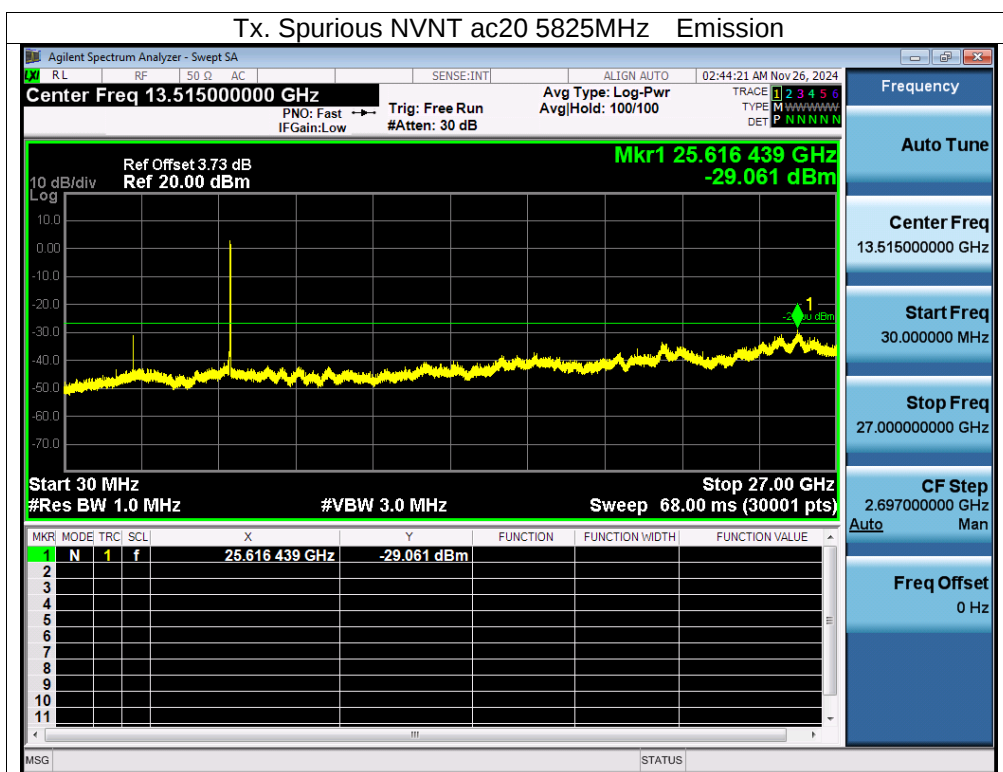


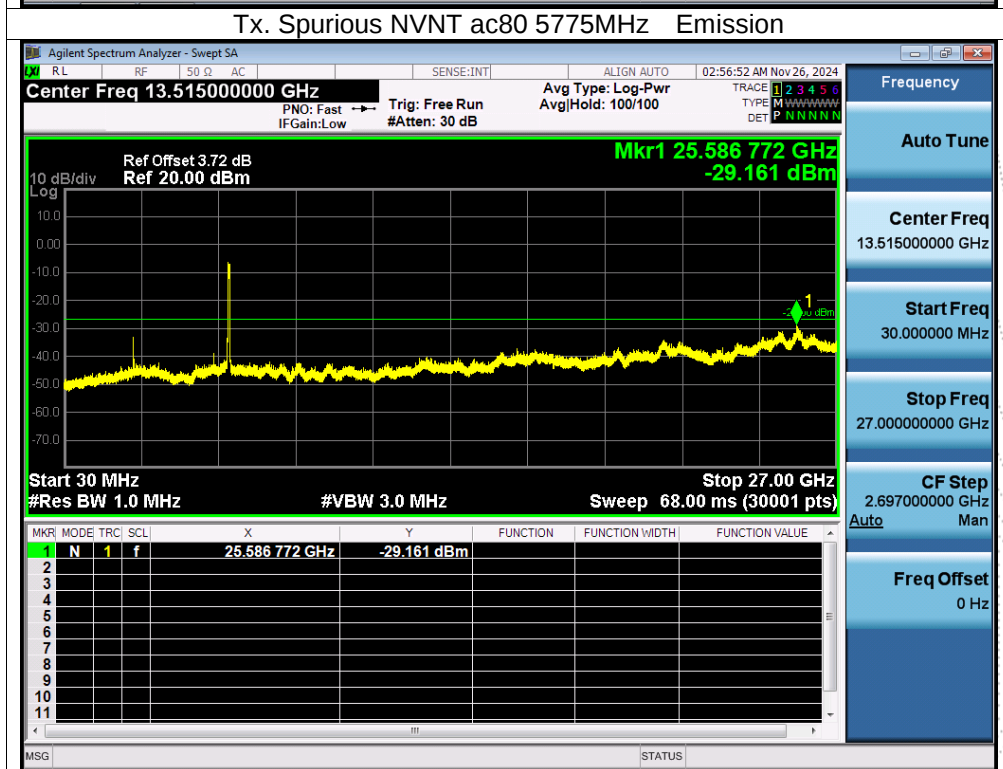
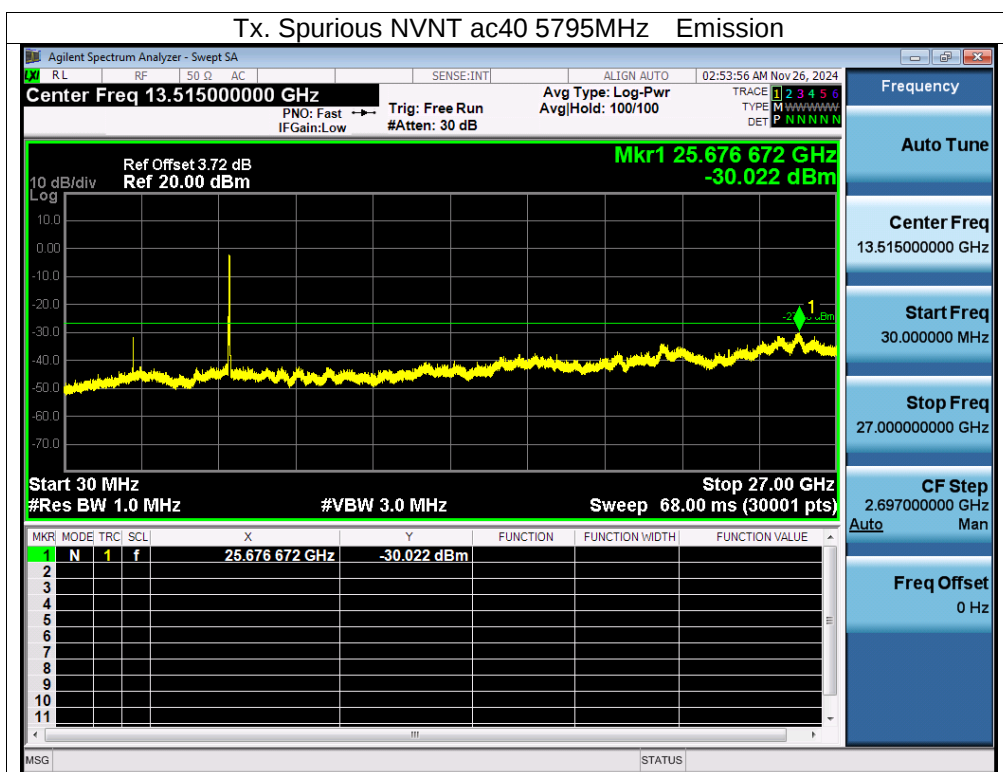












13. Frequency Stability Measurement

13.1 Block Diagram Of Test Setup



13.2 Limit

Manufactures of U-NII devices are responsible for ensuring frequency stability such that an emission is maintained within the band of operation under all conditions of normal operation as specified in the user's manual.

The transmitter center frequency tolerance shall be ± 20 ppm maximum for the 5 GHz band (IEEE 802.11n specification)..

13.3 Test Procedure

1. The transmitter output (antenna port) was connected to the spectrum analyzer.
2. EUT have transmitted absence of modulation signal and fixed channelize.
3. Set the spectrum analyzer span to view the entire absence of modulation emissions bandwidth.
4. Set RBW = 10 kHz, VBW = 10 kHz with peak detector and maxhold settings.
5. f_c is declaring of channel frequency. Then the frequency error formula is $(f_c - f)/f_c \times 10^6$ ppm and he limit is less than ± 20 ppm (IEEE 802.11n specification).
6. The test extreme voltage is to change the primary supply voltage from 85 to 115 percent of the nominal value
7. Extreme temperature is $-20^\circ\text{C} \sim 70^\circ\text{C}$.

13.4 Test Result

Temperature:	26 °C	Relative Humidity:	54%
Pressure:	101kPa	Test Voltage:	DC 3.9V
Test Mode:	TX Frequency U-NII-1 (5180-5240MHz)		

Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency : 5180MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	3.90	5180.0098	5180	0.0098	1.8919
		V max (V)	4.49	5180.0036	5180	0.0036	0.6950
		V min (V)	3.32	5180.0016	5180	0.0016	0.3089
Limits				5150-5250 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5180MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	3.9	T (°C)	-20	5180.0096	5180	0.0096	1.8533
		T (°C)	-10	5180.0070	5180	0.0070	1.3514
		T (°C)	0	5180.0000	5180	0.0000	0.0000
		T (°C)	10	5180.0029	5180	0.0029	0.5598
		T (°C)	20	5180.0027	5180	0.0027	0.5212
		T (°C)	30	5180.0073	5180	0.0073	1.4093
		T (°C)	40	5180.0041	5180	0.0041	0.7915
		T (°C)	50	5180.0015	5180	0.0015	0.2896
		T (°C)	60	5180.0058	5180	0.0058	1.1197
		T (°C)	70	5180.0076	5180	0.0076	1.4672
Limits				5150-5250 MHz			
Result				Complies			

Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5200MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	3.90	5200.0098	5200	0.0098	1.8846
		V max (V)	4.49	5200.0009	5200	0.0009	0.1731
		V min (V)	3.32	5200.0132	5200	0.0132	2.5385
Limits				5150-5250 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5200MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	3.9	T (°C)	-20	5200.00810	5200	0.00810	1.5577
		T (°C)	-10	5200.01270	5200	0.01270	2.4423
		T (°C)	0	5200.00230	5200	0.00230	0.4423
		T (°C)	10	5200.00270	5200	0.00270	0.5192
		T (°C)	20	5200.00380	5200	0.00380	0.7308
		T (°C)	30	5200.00000	5200	0.00000	0.0000
		T (°C)	40	5200.00910	5200	0.00910	1.7500
		T (°C)	50	5200.00310	5200	0.00310	0.5962
		T (°C)	60	5200.01000	5200	0.01000	1.9231
		T (°C)	70	5200.01190	5200	0.01190	2.2885
Limits				5150-5250 MHz			
Result				Complies			

Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5240MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	3.90	5240.0129	5240	0.0129	2.4618
		V max (V)	4.49	5240.0023	5240	0.0023	0.4389
		V min (V)	3.32	5240.0014	5240	0.0014	0.2672
Limits				5150-5250 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5240MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	3.9	T (°C)	-20	5240.0125	5240	0.0125	2.3855
		T (°C)	-10	5240.0042	5240	0.0042	0.8015
		T (°C)	0	5240.0113	5240	0.0113	2.1565
		T (°C)	10	5240.0029	5240	0.0029	0.5534
		T (°C)	20	5240.0103	5240	0.0103	1.9656
		T (°C)	30	5240.0125	5240	0.0125	2.3855
		T (°C)	40	5240.0087	5240	0.0087	1.6603
		T (°C)	50	5240.0009	5240	0.0009	0.1718
		T (°C)	60	5240.0082	5240	0.0082	1.5649
		T (°C)	70	5240.0096	5240	0.0096	1.8321
Limits				5150-5250 MHz			
Result				Complies			

Temperature:	26 °C	Relative Humidity:	54%
Pressure:	101kPa	Test Voltage:	DC 3.9V
Test Mode:	TX Frequency(5745-5825MHz)		

Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5745MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	3.90	5745.01230	5745	0.01230	2.1410
		V max (V)	4.49	5745.01300	5745	0.01300	2.2628
		V min (V)	3.32	5745.01300	5745	0.01300	2.2628
Limits				5725-5850 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5745MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	3.9	T (°C)	-20	5745.00560	5745	0.00560	0.9748
		T (°C)	-10	5745.00680	5745	0.00680	1.1836
		T (°C)	0	5745.00600	5745	0.00600	1.0444
		T (°C)	10	5745.01100	5745	0.01100	1.9147
		T (°C)	20	5745.01250	5745	0.01250	2.1758
		T (°C)	30	5745.00370	5745	0.00370	0.6440
		T (°C)	40	5745.00340	5745	0.00340	0.5918
		T (°C)	50	5745.00310	5745	0.00310	0.5396
		T (°C)	60	5745.00270	5745	0.00270	0.4700
		T (°C)	70	5745.00910	5745	0.00910	1.5840
Limits				5725-5850 MHz			
Result				Complies			

Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5785MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	3.90	5785.00300	5785	0.00300	0.5186
		V max (V)	4.49	5785.01260	5785	0.01260	2.1780
		V min (V)	3.32	5785.01280	5785	0.01280	2.2126
Limits				5725-5850 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5785MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	3.9	T (°C)	-20	5785.01290	5785	0.01290	2.2299
		T (°C)	-10	5785.00170	5785	0.00170	0.2939
		T (°C)	0	5785.01020	5785	0.01020	1.7632
		T (°C)	10	5785.01210	5785	0.01210	2.0916
		T (°C)	20	5785.01040	5785	0.01040	1.7978
		T (°C)	30	5785.00220	5785	0.00220	0.3803
		T (°C)	40	5785.00200	5785	0.00200	0.3457
		T (°C)	50	5785.00560	5785	0.00560	0.9680
		T (°C)	60	5785.00230	5785	0.00230	0.3976
		T (°C)	70	5785.00670	5785	0.00670	1.1582
Limits				5725-5850 MHz			
Result				Complies			

Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5825MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	3.90	5825.01280	5825	0.01280	2.1974
		V max (V)	4.49	5825.00830	5825	0.00830	1.4249
		V min (V)	3.32	5825.01210	5825	0.01210	2.0773
Limits				5725-5850 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5825MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	3.9	T (°C)	-20	5825.01080	5825	0.01080	1.8541
		T (°C)	-10	5825.00940	5825	0.00940	1.6137
		T (°C)	0	5825.00500	5825	0.00500	0.8584
		T (°C)	10	5825.00040	5825	0.00040	0.0687
		T (°C)	20	5825.01050	5825	0.01050	1.8026
		T (°C)	30	5825.00060	5825	0.00060	0.1030
		T (°C)	40	5825.00950	5825	0.00950	1.6309
		T (°C)	50	5825.00230	5825	0.00230	0.3948
		T (°C)	60	5825.00440	5825	0.00440	0.7554
		T (°C)	70	5825.01070	5825	0.01070	1.8369
Limits				5725-5850 MHz			
Result				Complies			

14. Duty Cycle Of Test Signal

14.1 Standard Requirement

Pre-analysis Check: While conducting average power measurement, duty cycle of each mode shall be checked to ensure its duty cycle in order to compensate for the loss due to insufficient ratio of duty cycle. All duty cycle is pre-scanned, and result as obtained below shows only the most representative ones where duty cycle is conducted as the given transmission with given virtual operation that expresses the percentage.

14.2 Formula

Duty Cycle = $T_{on} / (T_{on} + T_{off})$

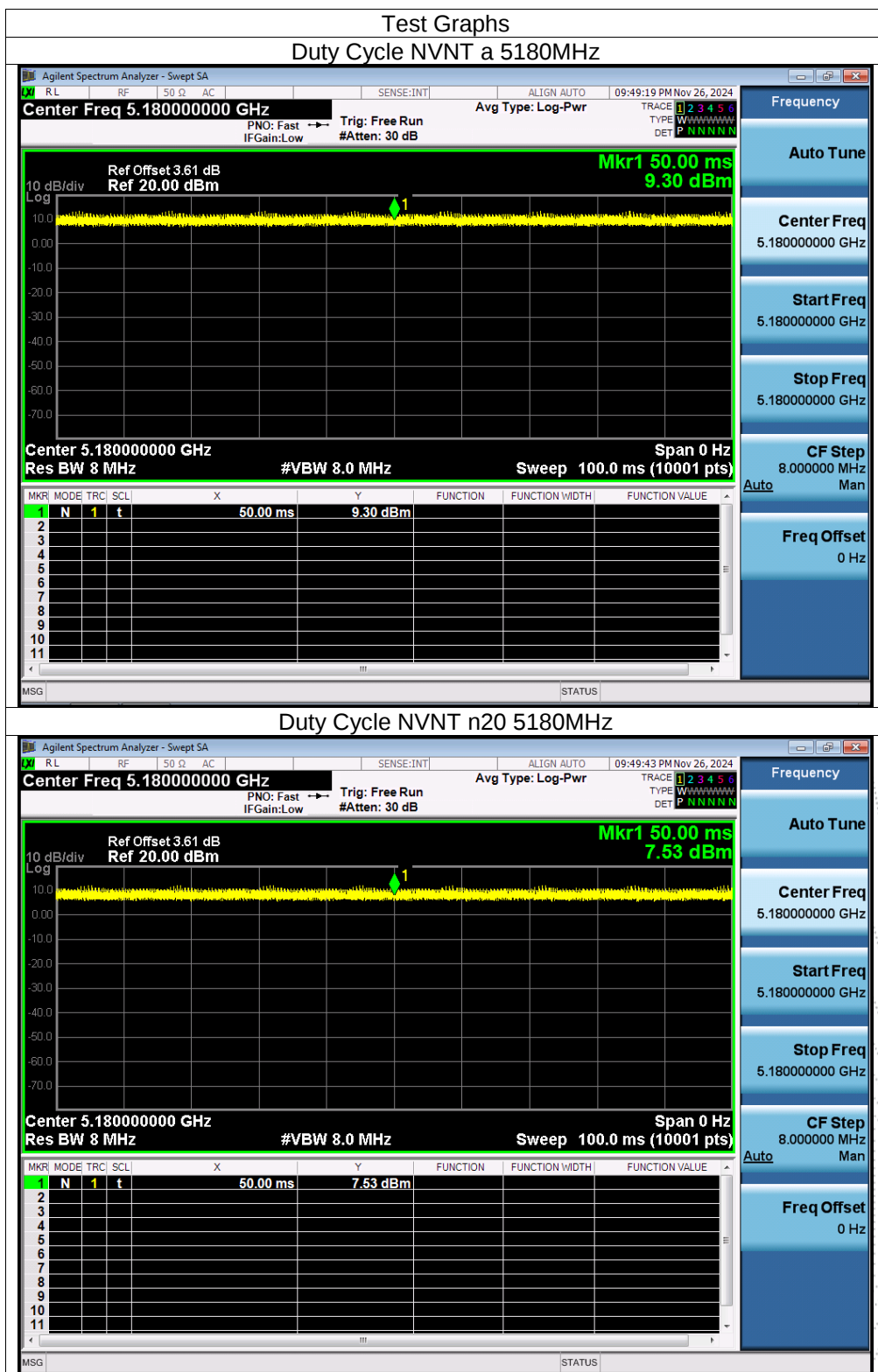
14.3 Test Procedure

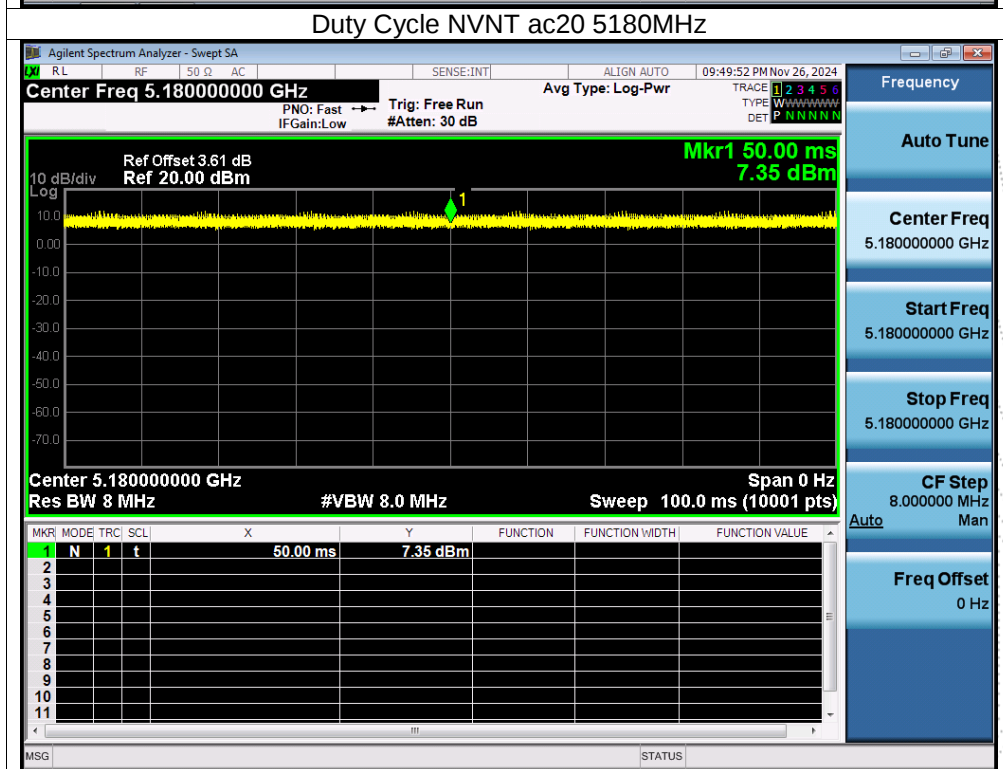
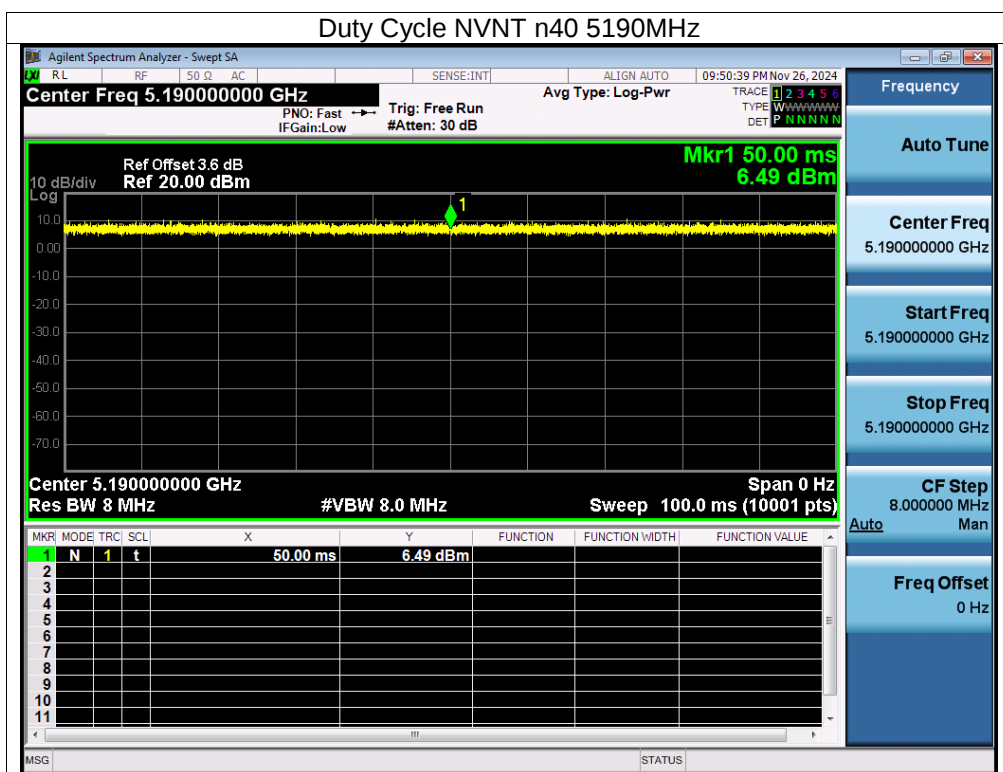
1. Set span = Zero
2. RBW = 8MHz
3. VBW = 8MHz,
4. Detector = Peak

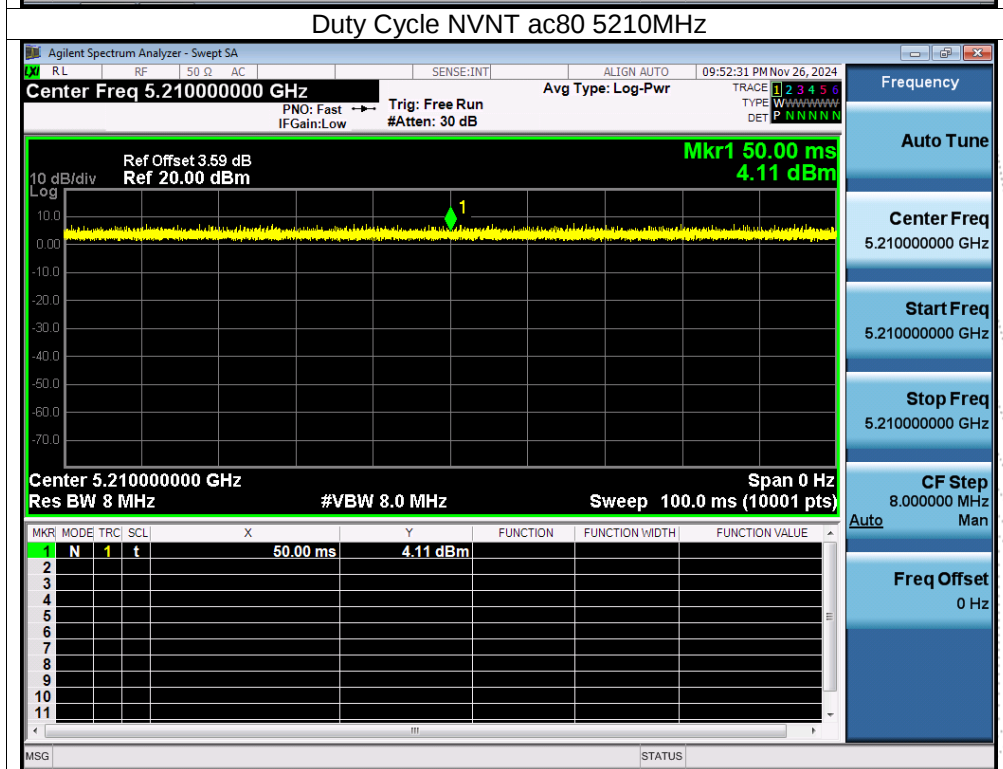
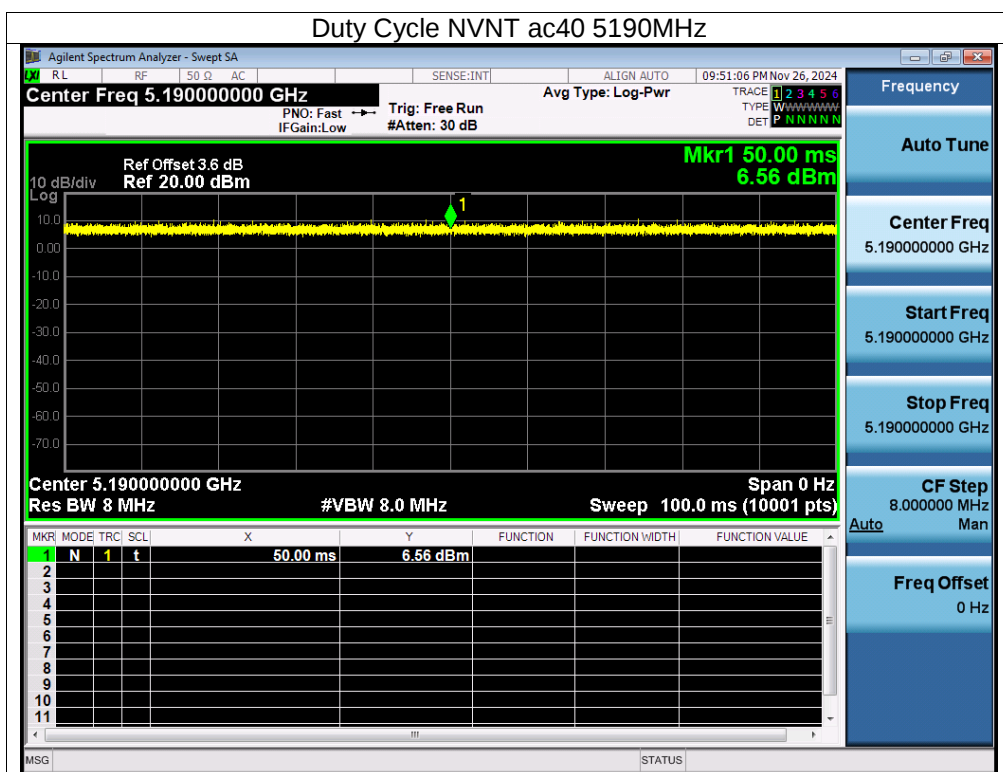
14.4 Test Result

5.1G

Condition	Mode	Frequency (MHz)	Duty Cycle (%)	Correction Factor (dB)	1/T (kHz)
NVNT	a	5180	100	0	0
NVNT	n20	5180	100	0	0
NVNT	n40	5190	100	0	0
NVNT	ac20	5180	100	0	0
NVNT	ac40	5190	100	0	0
NVNT	ac80	5210	100	0	0







5.8G

Condition	Mode	Frequency (MHz)	Duty Cycle (%)	Correction Factor (dB)	1/T (kHz)
NVNT	a	5745	100	0	0
NVNT	n20	5745	100	0	0
NVNT	n40	5755	100	0	0
NVNT	ac20	5745	100	0	0
NVNT	ac40	5755	100	0	0
NVNT	ac80	5775	100	0	0

